



## APPLICATION FOR ELECTROMAGNETIC COMPATIBILITY DIRECTIVE

On Behalf of

Shenzhen UniMAT Automation Technology Co.,LTD

PROGRAMMABLE LOGIC CONTROLLER(PLC)

Model No.: CPU SR20XP, CPU SR20, CPU SR30, CPU SR40, CPU  
SR60

Prepared for : Shenzhen UniMAT Automation Technology Co.,LTD  
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Report Number : A2306145-C01-R02  
Date of Receipt : July 26, 2023  
Date of Test : July 27-28, 2023  
Date of Report : July 31, 2023  
Version Number : V0

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## TEST REPORT DECLARATION

Applicant : Shenzhen UniMAT Automation Technology Co.,LTD  
Address : 19F, Hangsheng Technology Building, No.8, Gaoxin South Sixth Road,  
Nanshan District, Shenzhen City  
Manufacturer : Shenzhen UniMAT Automation Technology Co.,LTD  
Address : 19F, Hangsheng Technology Building, No.8, Gaoxin South Sixth Road,  
Nanshan District, Shenzhen City  
EUT Description : PROGRAMMABLE LOGIC CONTROLLER(PLC)  
(A) Model No. : CPU SR20XP, CPU SR20, CPU SR30, CPU SR40, CPU SR60  
(B) Trademark : /

Measurement Standard Used:

**EN 55032:2015+A1:2020**

**EN 55035:2017+A11:2020**

**EN IEC 61000-3-2:2019+A1:2021**

**EN 61000-3-3:2013+A2:2021**

The device described above is tested by Shenzhen Alpha Product Testing Co., Ltd. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The test results are contained in this test report and Shenzhen Alpha Product Testing Co., Ltd. is assumed full responsibility for the accuracy and completeness of test. Also, this report shows that the EUT is technically compliant with the EN 55032, EN IEC 61000-3-2, EN 61000-3-3 and EN 55035 requirements.

This report applies to above tested sample only. This report shall not be reproduced in parts without written approval of Shenzhen Alpha Product Testing Co., Ltd.

Tested by (name + signature).....: Jerry Yin  
Project Engineer

Approved by (name + signature).....: Reak Yang  
Project Manager

Date of issue.....: July 31, 2023



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## Revision History

Revision	Issue Date	Revisions	Revised By
V0	July 31, 2023	Initial released Issue	Jerry Yin

## 1. General Information

### 1.1. Description of Device (EUT)

Description	: PROGRAMMABLE LOGIC CONTROLLER(PLC)
Model Number	: CPU SR20XP, CPU SR20, CPU SR30, CPU SR40, CPU SR60
Diff	: There is no difference except the name of the model. All tests are made with the CPU SR20XP model.
Test Voltage	: AC 230V/50Hz, AV 120V/60Hz
EUT information	: Input : AC 85~264V.12A(Max) Output: :DC 24V 0.3A(Max)
Highest frequency	: More than 108MHz
Software version	: N/A
Hardware version	: N/A

### 1.2. Accessories of Device (EUT)

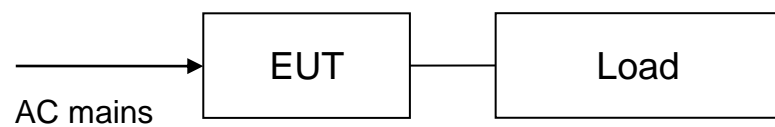
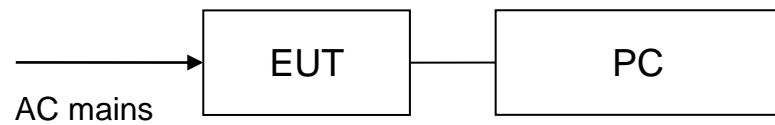
Power Source	: Power from AC Mains
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### 1.3. Tested Supporting System Details

No.	Description	Manufacturer	Model	Serial Number
1	Portable laptop	Lenovo	ThinkPad E14	PF-29216Q
2	Load	/	/	/

### 1.4. Block Diagram of connection between EUT and simulators

For test



Signal Cable Description of the above Support Units					
No.	Port Name	Cable	Length	Shielded (Yes or No)	Detachable (Yes or No)
(a)	/	/	/	/	/
(b)	/	/	/	/	/



## 2. Summary Of Standards And Results

### 2.1. Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below:

EMISSION				
Description of Test Item	Standard	Limits	Results	
Radiated Emissions	EN 55032:2015+A1:2020	Annex A.4 & A.5	P	
Radiated Emissions From FM Receivers	EN 55032:2015+A1:2020	Annex A.6	N/A	
Conducted Emissions From The AC Mains Power Ports	EN 55032:2015+A1:2020	Annex A.10	P	
Conducted Emissions From Asymmetric Mode	EN 55032:2015+A1:2020	Annex A.12	N/A	
Conducted Differential Voltage Emissions	EN 55032:2015+A1:2020	Annex A.13	N/A	
Harmonic current emissions	EN IEC 61000-3-2:2019+A1:2021	Section 7	N/A	
Voltage fluctuations & flicker	EN 61000-3-3:2013+A2:2021	Section 5	P	
IMMUNITY (EN 55035:2017+A11:2020)				
Description of Test Item	Standard	Performance Criteria	Observation Criteria	Results
Electrostatic discharge (ESD)	IEC 61000-4-2:2008	B	A	P
Radio-frequency, Continuous radiated disturbance	IEC 61000-4-3:2006+ A1:2007 + A2:2010	A	A	P
Electrical fast transient (EFT)	IEC 61000-4-4:2012	B	A	P
Surge (Input a.c. power port)	IEC 61000-4-5:2014+ A1:2017	B	A	P
Surge(Telecommunication port)		B	A	P
Radio-frequency, Continuous conducted disturbance	IEC 61000-4-6:2013	A	A	P
Broadband impulsive conducted disturbances		A	N/A	N/A
Power frequency magnetic field	IEC 61000-4-8:2009	A	N/A	N/A
Voltage dips, >95% reduction	IEC 61000-4-11:2020	B	A	P
Voltage dips, 30% reduction		C	B	P
Voltage interruptions, >95% reduction		C	B	P
<div>Note:</div> <div><div>1. P is an abbreviation for Pass.</div><div>2. F is an abbreviation for Fail.</div><div>3. N/A is an abbreviation for Not Applicable.</div><div>4. Decision rules for the conclusion of this test report: decision by actual test data without considering measurement uncertainty.</div></div>				

## 2.2. Test Mode Description

For Tests		
Mode No.	Test Mode	Test Voltage
Mode 1	Full Load	AC 230V/50Hz
Mode 2	Data transmission	AC 230V/50Hz
Mode 3	Full Load	AC 120V/60Hz
Mode 4	Data transmission	AC 120V/60Hz
Note: Mode 2 is worst case mode tests, so this report only reflected the worst mode in this part.		

### 2.3. Test Facility

Shenzhen Alpha Product Testing Co., Ltd.

Building i, No.2, Lixin Road, Fuyong Street, Bao'an District, 518103,  
Shenzhen, Guangdong, China

### 2.4. Measurement Uncertainty

Test Item	Uncertainty	U <sub>cispr</sub>
Uncertainty for Conduction emission test	1.63dB	3.8 dB
Uncertainty for Radiation Emission test (<1G)	3.74 dB (Distance: 3m Polarize: V)	5.2 dB
	3.76 dB (Distance: 3m Polarize: H)	
Uncertainty for Radiation Emission test (>1G)	3.77 dB (Distance: 3m Polarize: V)	5.2 dB
	3.80 dB (Distance: 3m Polarize: H)	
(95% confidence levels, k=2)		

## 2.5. Test Equipment List

For Power Line Conducted Emission Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	Test Receiver	Rohde&Schwarz	ESCI	101165	4.42 SP1	2022.08.22	1 Year
2.	L.I.S.N.#1	Schwarz beck	NSLK8126	8126-466	/	2022.08.22	1 Year
3.	L.I.S.N.#2	Rohde&Schwarz	ENV216	101043	/	2022.08.22	1 Year
4.	Pulse Limiter	Schwarz beck	9516F	9618	/	2022.08.22	1 Year
5.	ISN	SCHWARZBECK	CAT5 8158	00316	/	2023.03.30	1 Year
6.	ISN	SCHWARZBECK	NTFM 8158	00273	/	2023.03.30	1 Year
7.	ISN	SCHWARZBECK	CAT3 8158	CAT3 8158 #167	/	2023.03.30	1 Year

For Frequency Range 30MHz~1GHz Radiated Emission Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1	Test Receiver	Rohde&Schwarz	ESR	1316.3003K03-102082-Wa	2.28 SP1	2022.08.22	1 Year
3	Bilog Antenna	Schwarz beck	VULB 9168	VULB 9168#627	/	2021.08.30	2 Year

For Frequency Range above 1GHz Radiated Emission Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1	Spectrum Analyzer	Rohde&Schwarz	FSU	200002	4.71.SP5	2022.08.22	1 Year
2	Horn Antenna	Schwarz beck	BBHA 9120 D	02106	/	2021.08.30	2 Year
3	Amplifier	Agilent	8449B	3008A02664	/	2022.08.22	1 Year

For Harmonic Current Test & Voltage Fluctuations & Flicker Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	Harmonics Flicker Analyser	Voltech	PM6000	200006700495	/	2022.08.22	1 Year
2.	HARMINICS&FLICKER MEASUREMENT SYSTEM	EVERFINE	HFM300_V200	P630850TD1411113	/	2023.04.21	1Year

## For Electrostatic Discharge Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	ESD Tester	HAEFELY	PESD1610	H310546	/	2022.08.22	1 Year.

## For RF Field Strength Susceptibility Test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	vector Signal Generator	Agilent	E4438C	US44271917	/	2022.08.22	1 Year
2.	Power meter	Agilent	E4419B	GB40202122	/	2022.08.22	1 Year
3.	Power Sensor	Agilent	E9300A	MY41496625s	/	2022.08.22	1 Year
4.	RF power Amplifier	OPHIR	5225R	1045	/	2022.08.22	1 Year
5.	RF power Amplifier	OPHIR	5273R	1018	/	2022.08.22	1 Year
6	RF power Amplifier	Micotop	MPA-3000-6000-100	MPA1811348	/	2022.08.22	1 Year
7.	Antenna	SCHWARZBECK	STLP9128E-special	STLP9128Es#139	/	N/A	NCR
8.	Antenna	SCHWARZBECK	STLP 9149	STLP 9149 #456	/	N/A	NCR

## For Electrical Fast Transient/Burst Immunity, Surge, Power Frequency Magnetic Field Immunity, Voltage dips and interruptions test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	Multifunctional Compact Immunity Test system	3ctest	CCS 600	ES0801655	CCS V4.0.9	2022.08.22	1 Year
2.	Surge & EFT Coupling Decoupling Network	3ctest	SEPN 3832T	ES0951601	/	2022.08.22	1 Year
3.	Voltage variation and PF magnetic field regulating device	3ctest	VMT2216S	ES0441601	/	2022.08.22	1 Year
4.	Capacitive Coupling Clamp	3ctest	CCC 100	EC0441660	/	2022.08.22	1 Year

## For Injected currents susceptibility test Equipment:

Item	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Last Cal.	Cal. Interval
1.	Conducted Immunity test System	SKET	CITS_150K230M	SK2019101001_CITS	/	2022.08.22	1 Year
2.	Fixed Coaxial Attenuator (6dB Attenuation)	CD	ATT-0675	120540086	/	2022.08.22	1 Year
3.	coupling-decoupling network (CDN)	CD	CDN M2/M3	2302	/	2022.08.22	1 Year
4.	Electromagnetic Injection Clamp (EMC-Clamp)	CD	EM-Clamp	0513A031201	/	2022.08.22	1 Year

## ForTest Software Information

Item	Software Name	Manufacturer	Version
RE	EZ-EMC	Farad	Alpha-3A1
CE	EZ-EMC	Farad	Alpha-3A1

### 3. Conducted Emissions Test

#### 3.1. Test Limit

Limit for Conducted Emissions at Mains Terminals Test

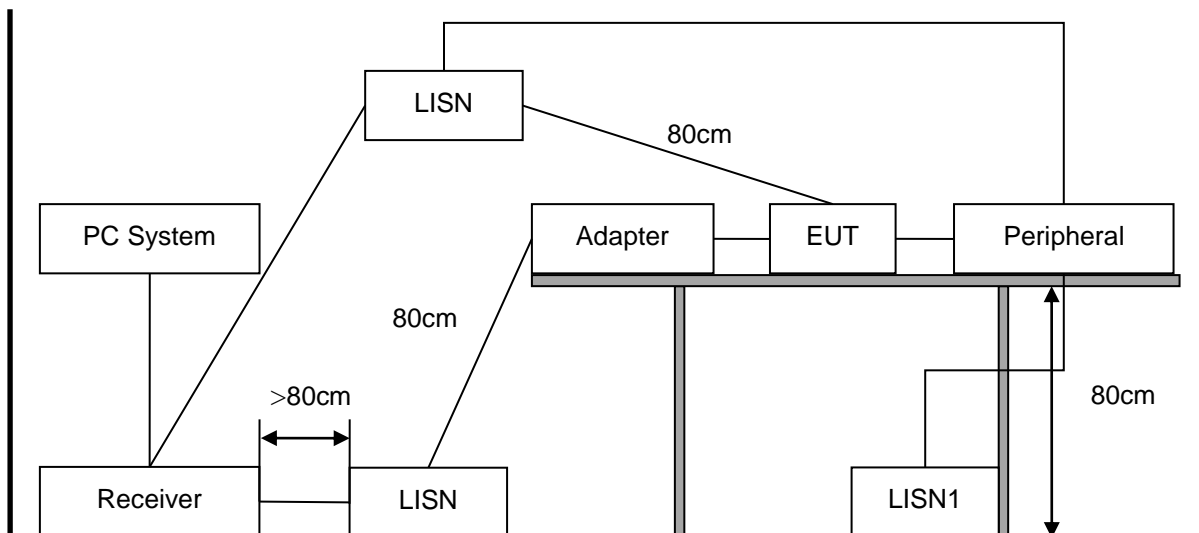
Frequency	Maximum RF Line Voltage	
	Quasi-Peak Level dB( $\mu$ V)	Average Level dB( $\mu$ V)
150kHz ~ 500kHz	66 ~ 56*	56 ~ 46*
500kHz ~ 5MHz	56	46
5MHz ~ 30MHz	60	50

Limit for Conducted Emissions From Asymmetric Mode Test

Frequency	Maximum RF Line Voltage	
	Quasi-Peak Level dB( $\mu$ V)	Average Level dB( $\mu$ V)
150kHz ~ 500kHz	84 ~ 74	74 ~ 64
500kHz ~ 30MHz	74	64

- Notes:
1. Emission level=Read level + LISN factor-Preamplifier factor + Cable loss
  2. \* Decreasing linearly with logarithm of frequency.
  3. The lower limit shall apply at the transition frequencies.

#### 3.2. Block Diagram of Test Setup



### 3.3. Configuration of EUT on Test

The following equipment are installed on conducted disturbance at mains terminals to meet the EN 55032 requirement and operating regulations in a manner which tends to maximize its emission characteristics in a normal application.

### 3.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 3.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 3.5. Test Procedure

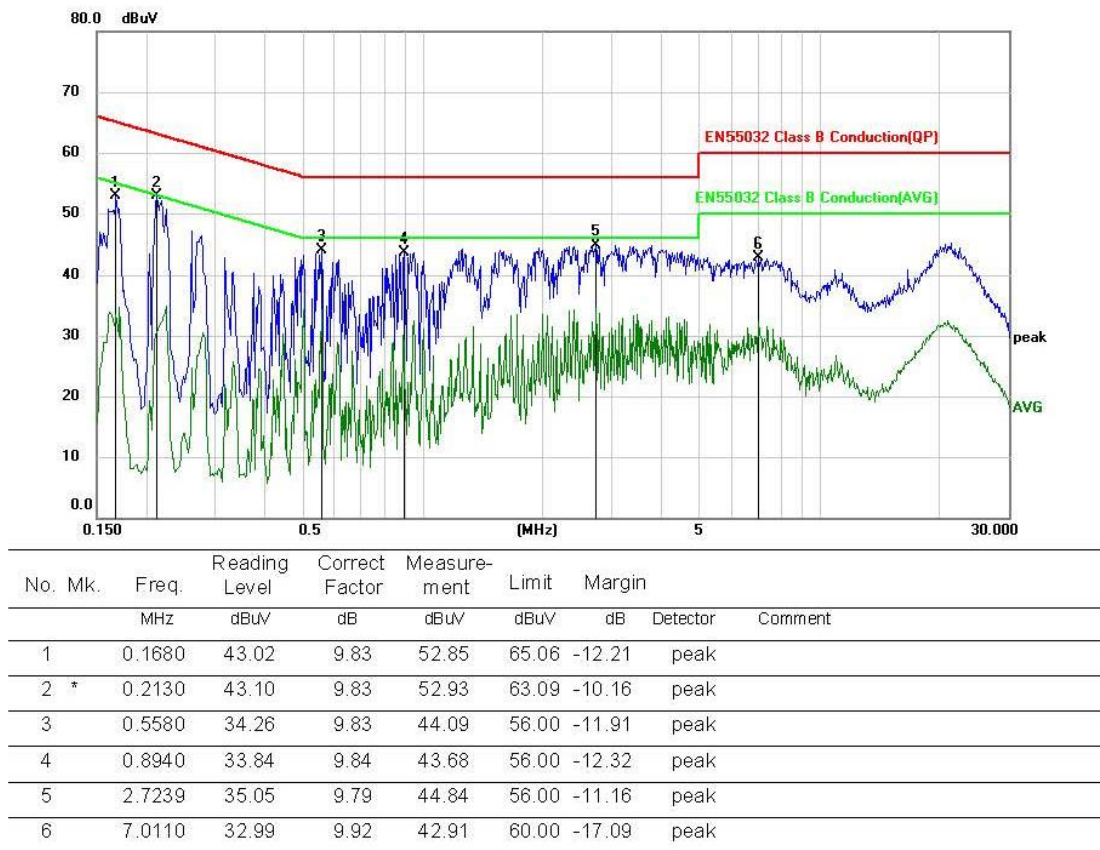
- (1) The EUT was placed on a non-metallic table, 80cm above the ground plane. The EUT Power connected to the power mains through a line impedance stabilization network (L.I.S.N. 1#). This provided a 50-ohm coupling impedance for the EUT (Please refer to the block diagram of the test setup and photographs). The other peripheral devices power cord connected to the power mains through a line impedance stabilization network (L.I.S.N.#2). Both sides of power line were checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipments and all of the interface cables were changed according to EN 55032 on Conducted Disturbance at Mains Terminals test.
- (2) The frequency range from 150kHz to 30MHz is checked, the bandwidth of test receiver (R&S TEST RECEIVER ESCI) is set at 9kHz.
- (3) The test results are reported on Section 3.6 & Section 3.7.



### 3.6. Conducted Emissions at Mains Terminals Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	2023.7.27
M/N	:	CPU SR20XP	Temperature	:	24℃
Test Engineer	:	Jerry Yin	Humidity	:	56%
Test Voltage	:	AC 230V/50Hz	Pressure	:	101.6kPa
Test Mode	:	Data transmission			
Test Results	:	PASS			
Note:					
1. The test results are listed in next pages.					
2. If the limits for the measurement with the average detector are met when using a receiver with a peak detector, the test unit shall be deemed to meet both limits and the measurement with the average detector and quasi-peak detector need not be carried out.					
3. If the limits for the measurement with the average detector are met when using a receiver with a quasi-peak detector, the test unit shall be deemed to meet both limits and the measurement with the average detector need not be carried out.					

## Polarization: Line

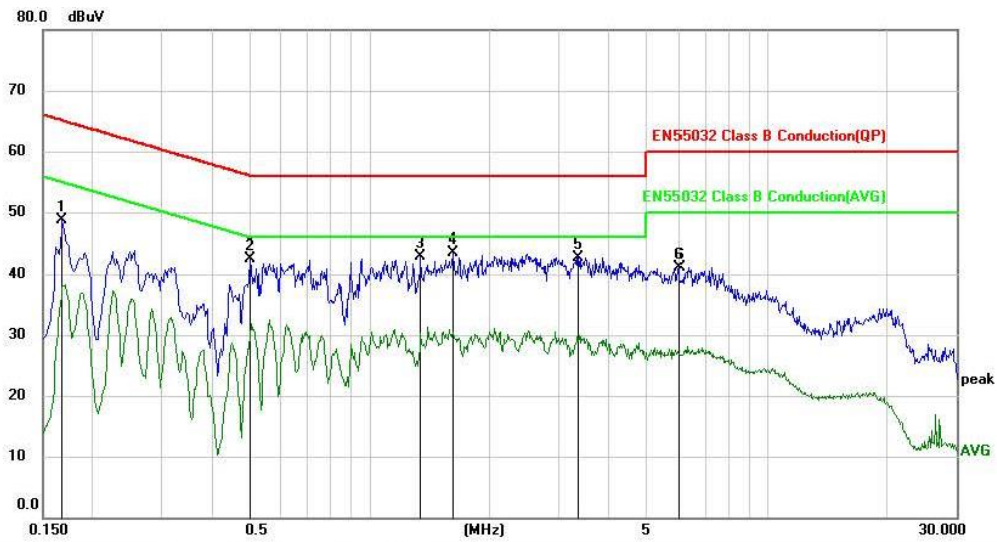


\*:Maximum data x:Over limit l:over margin

(Reference Only)

Note: Measurement=Reading Level+Correc Factor. Factor=(LISN or ISN or PLC or Current Probe)Factor+Cable

## Polarization: Neutral



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Margin dB	Detector	Comment
1		0.1680	38.91	9.83	48.74	65.06	-16.32	peak	
2		0.5010	32.58	9.83	42.41	56.00	-13.59	peak	
3		1.3410	33.02	9.82	42.84	56.00	-13.16	peak	
4	*	1.6140	33.67	9.79	43.46	56.00	-12.54	peak	
5		3.3540	32.97	9.82	42.79	56.00	-13.21	peak	
6		6.0210	31.17	9.91	41.08	60.00	-18.92	peak	

\*:Maximum data    x:Over limit    l:over margin

{Reference Only

Note: Measurement=Reading Level+Correc Factor    Factor=(LISN or ISN or PLC or Current Probe)Factor+Cable

### 3.7. Conducted Emissions From Asymmetric Mode Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	N/A
M/N	:	CPU SR20XP	Temperature	:	N/A
Test Engineer	:	N/A	Humidity	:	N/A
Test Voltage	:	N/A	Pressure	:	N/A
Test Mode	:	N/A			
Test Results	:	N/A			
Note	:	EUT has no RJ45 port and does not require testing			

## 4. Radiated Emissions Test

### 4.1. Test Limit

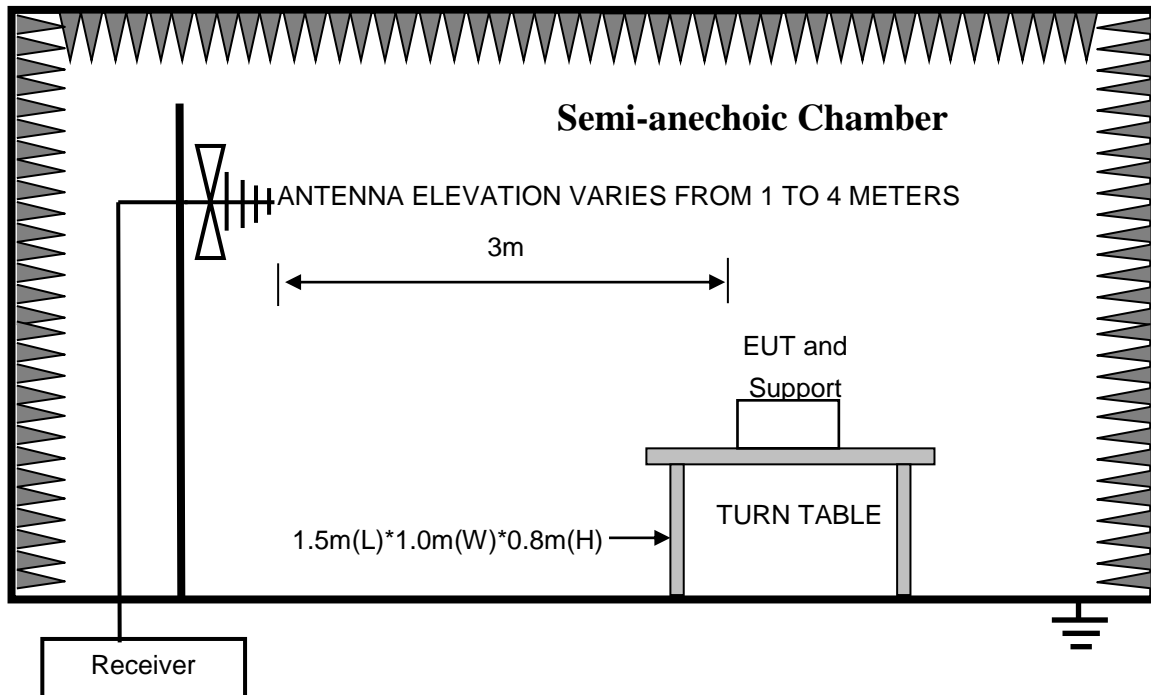
Frequency MHz			Distance (Meters)	Field Strengths Limits dB( $\mu$ V)/m
30	~	230	3	40
230	~	1000	3	47
1000	~	6000	3	74(Peak) 54(Average)

- Notes:
1. Emission level = Read level + Antenna Factor - Preamp Factor + Cable Loss
  2. The smaller limit shall apply at the cross point between two frequency bands.
  3. Distance is the distance in meters between the measuring instrument, antenna and the closest point of any part of the device or system.
  4. Frequency range of radiated measurements:

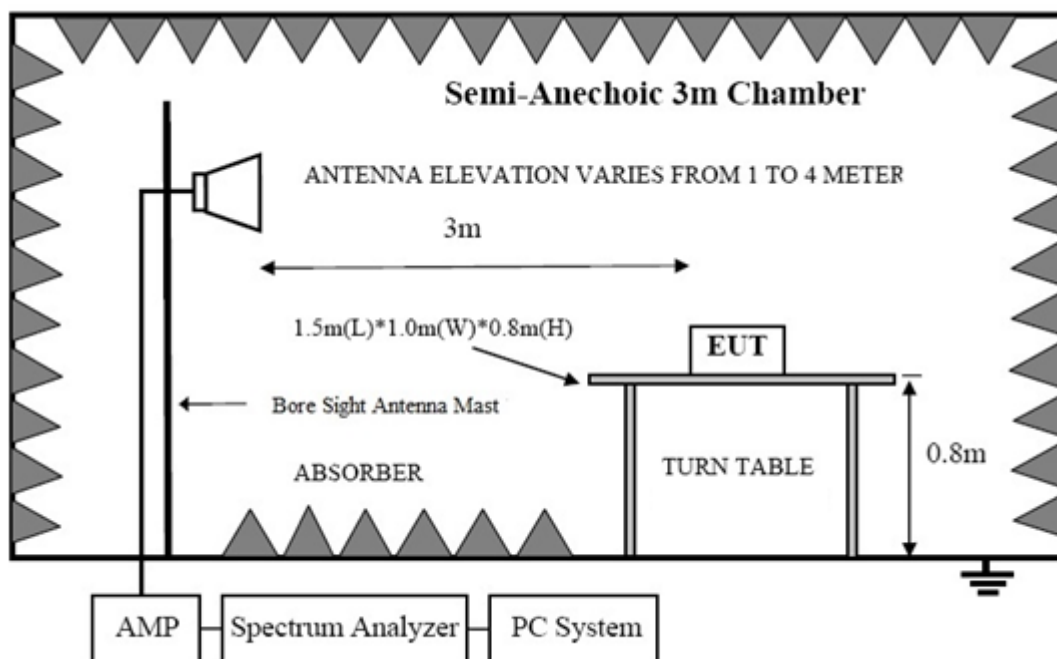
Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	5th harmonic of the highest frequency or 6 GHz, whichever is lower.

## 4.2. Block Diagram of Test Setup

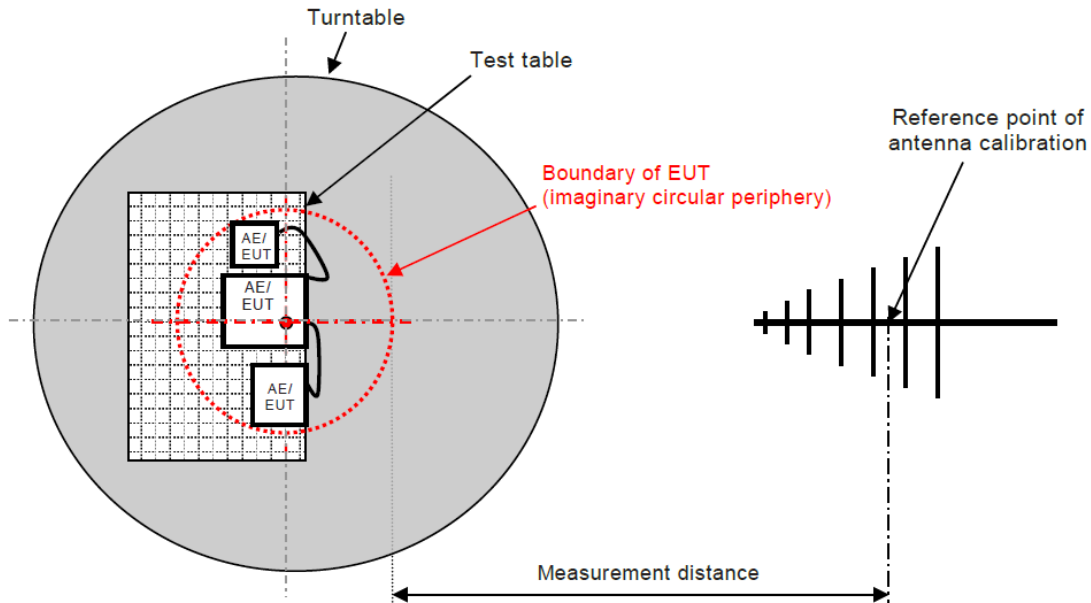
In Semi Anechoic Chamber (3m) Test Setup Diagram for 30MHz~1000MHz



In Semi Anechoic Chamber (3m) Test Setup Diagram for Above 1GHz



For 3m distance description:



#### 4.3. Configuration of EUT on Test

The following equipment are installed on Radiated Emission Test to meet the EN 55032 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

#### 4.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 4.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

#### 4.5. Test Procedure

- (1) The EUT was placed on a non-metallic table, 80 cm above the ground plane inside a semi-anechoic chamber. An antenna was located 3m from the EUT on an adjustable mast. A pre-scan was first performed in order to find prominent radiated emissions. For final emissions measurements at each frequency of interest, the EUT were rotated and the antenna height was varied between 1m and 4m in order to maximize the emission. Measurements in both horizontal and vertical polarities were made and the data was recorded. In order to find the maximum emission, the relative positions of equipments and all the interface cables were changed according to EN 55032 on Radiated Disturbance test.
- (2) The frequency range from 30MHz to 1000MHz is checked, the bandwidth of test receiver (R&S TEST RECEIVER ESR) is set at 120kHz.
- (3) The resolution bandwidth of the R&S Spectrum Analyzer FSU was set at 1MHz. (For above 1GHz)
- (4) The frequency range from 30MHz to 1000MHz was pre-scanned with a peak detector and all final readings of measurement from Test Receiver are Quasi-Peak values, all measurement distance is 3m in 3m semi anechoic chamber.

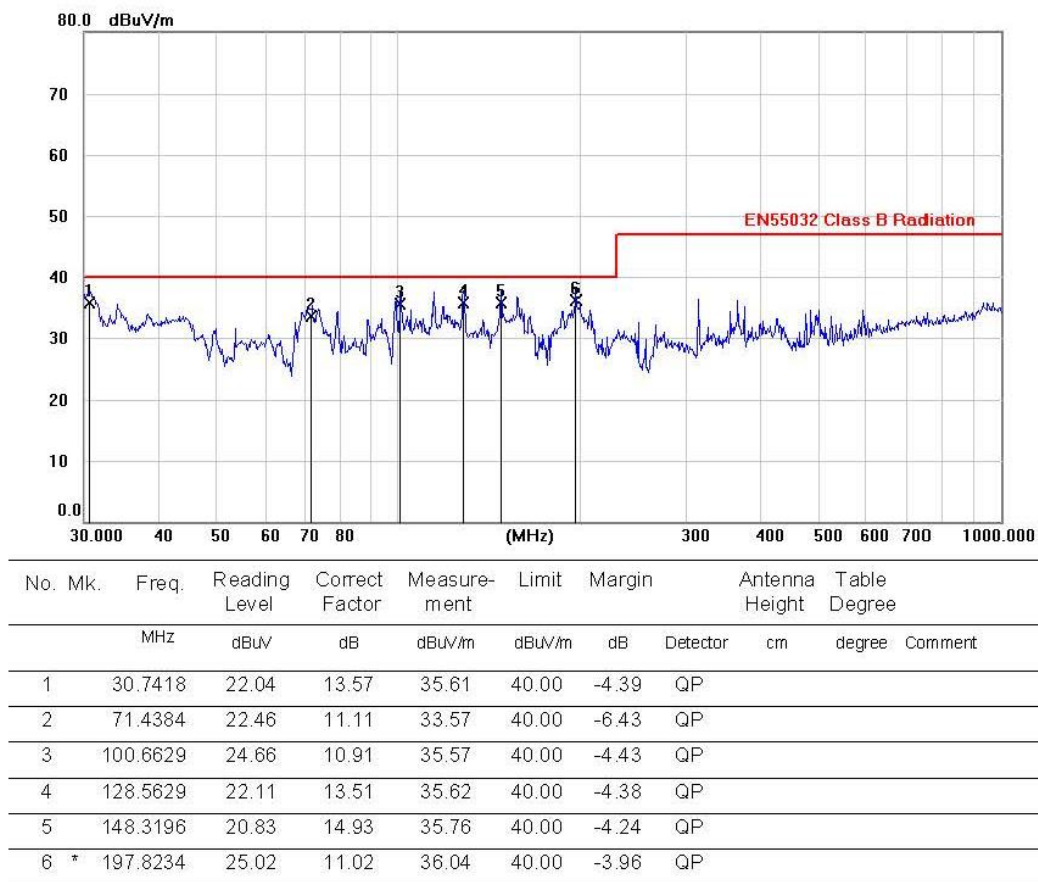
- (5) The frequency range from 1GHz to 6GHz was checked with peak and average detector, measurement distance is 3m in 3m chamber.
- (6) The test results are reported on Section 4.6.



#### 4.6. Radiated Emissions Test Results

For below 1G radiated disturbance test result:			
EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date : 2023.7.27
M/N	:	CPU SR20XP	Temperature : 24℃
Test Engineer	:	Jerry Yin	Humidity : 56%
Test Voltage	:	AC 230/50Hz	Pressure : 101.6kPa
Test Mode	:	Data transmission	
Test Results	:	PASS	
Note: 1. The test results are listed in next pages. 2. If the limits for the measurement with the quasi-peak detector are met when using a receiver with a peak detector, the test unit shall be deemed to meet limits and the measurement with the quasi-peak detector need not be carried out.			

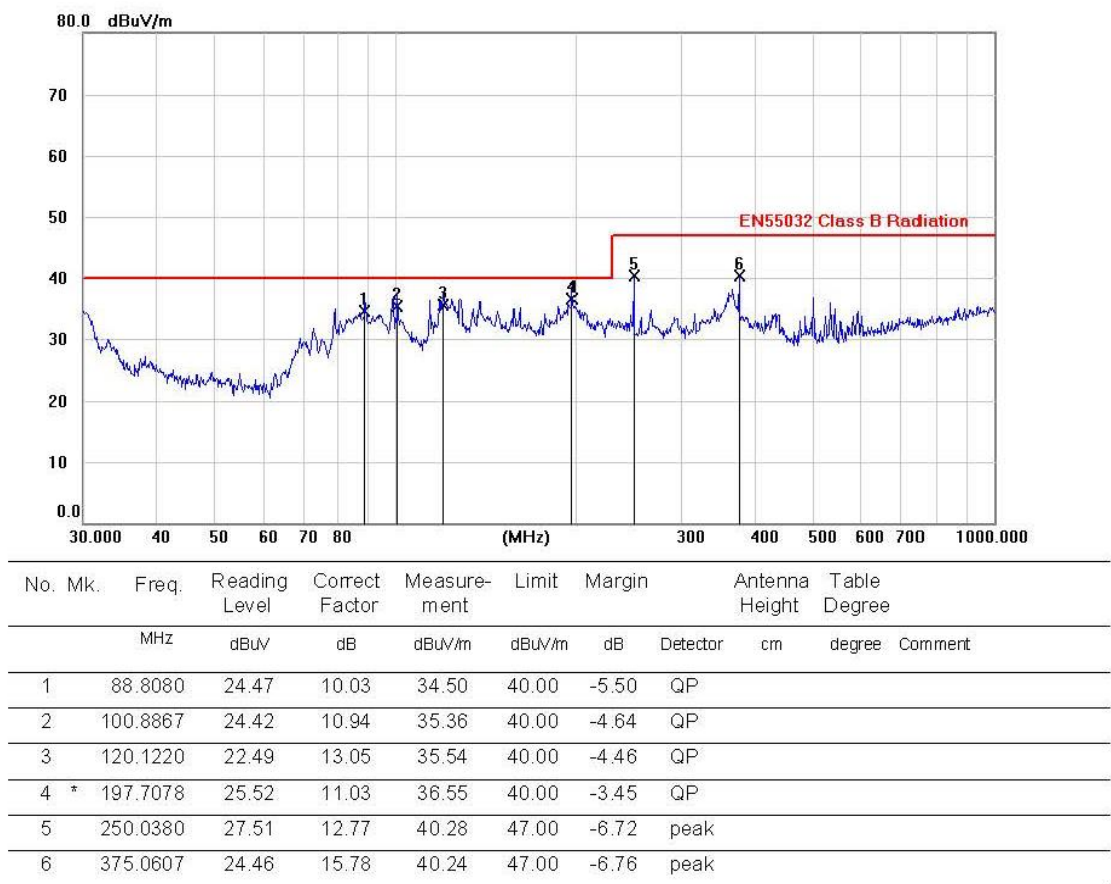
## Antenna Polarity: Vertical



Note: 1. \*: Maximum data; x: Over limit; !: over margin.

2. Measurement=Reading Level+Correct Factor; Correct Factor=Antenna Factor+Cable Loss.

## Antenna Polarity: Horizontal



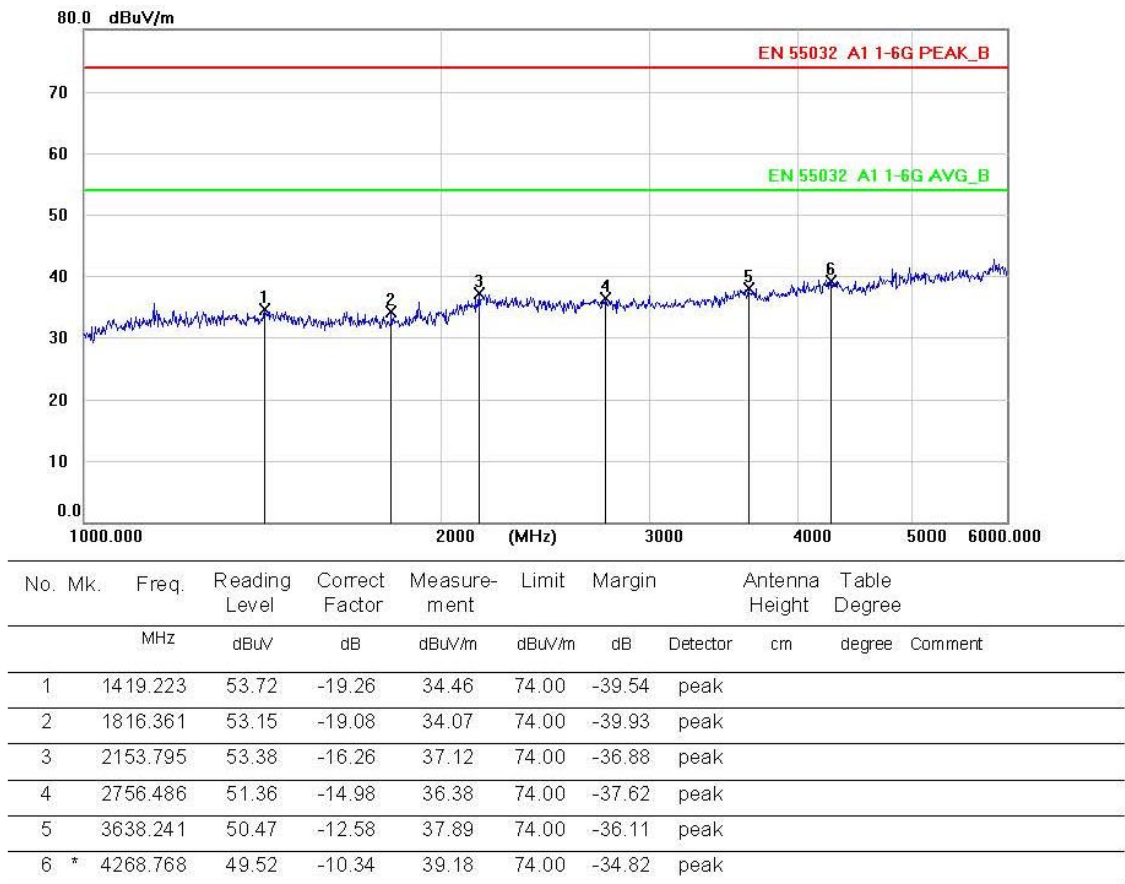
Note: 1. \*: Maximum data; x: Over limit; l: over margin.

2. Measurement=Reading Level+Correct Factor; Correct Factor=Antenna Factor+Cable Loss.

For above 1G radiated emissions test result:

EUT	: PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	: 2023.7.27
M/N	: CPU SR20XP	Temperature	: 24℃
Test Engineer	: Jerry Yin	Humidity	: 56%
Test Voltage	: AC 230/50Hz	Pressure	: 101.6kPa
Test Mode	: Data transmission		
Test Results	: PASS		
Note:	<ol style="list-style-type: none"><li>1. The test results are listed in next pages.</li><li>2. If the limits for the measurement with the average detector are met when using a receiver with a peak detector, the test unit shall be deemed to meet limits and the measurement with the average detector need not be carried out.</li></ol>		

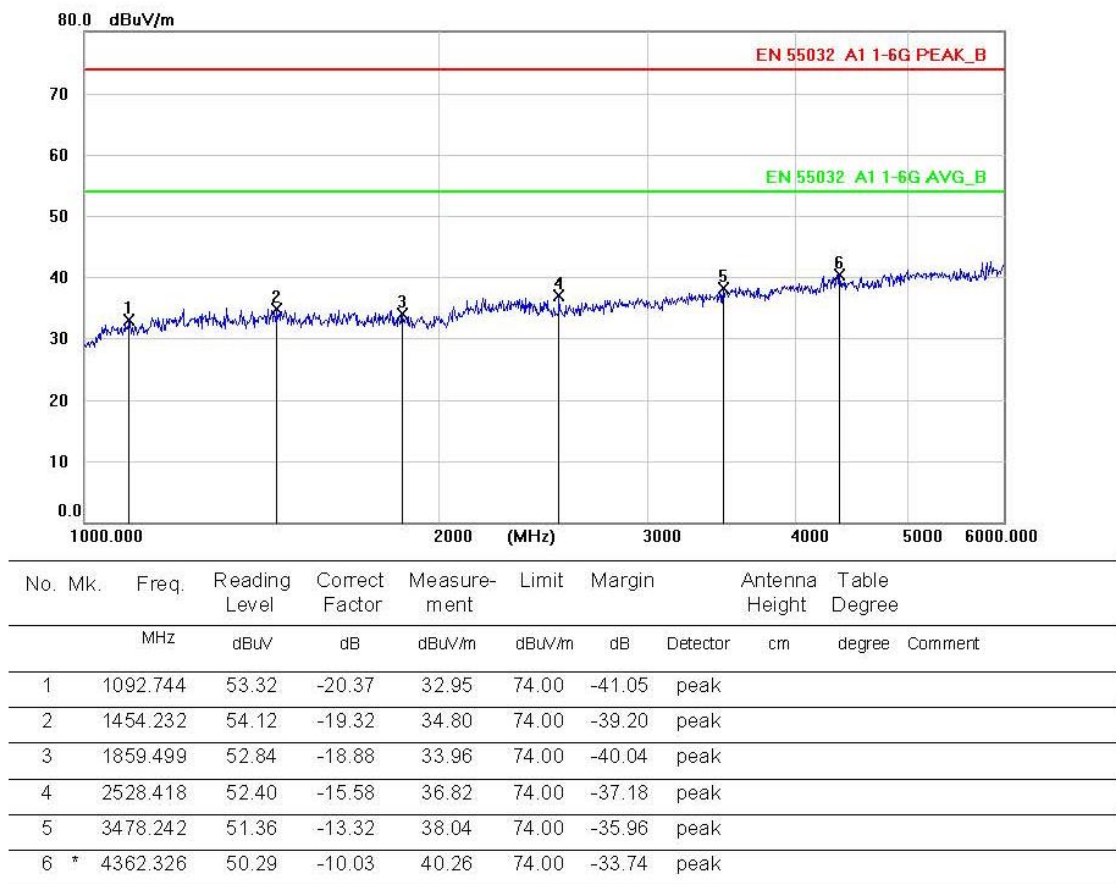
## Antenna Polarity: Vertical



Note: 1. \*:Maximum data; x:Over limit; l:over margin.

2.Measurement=Reading Level+Correct Factor; Correct Factor=Antenna Factor+Cable Loss.

## Antenna Polarity: Horizontal



Note: 1. \*: Maximum data; x: Over limit; !: over margin.

2. Measurement=Reading Level+Correct Factor; Correct Factor=Antenna Factor+Cable Loss.

## 5. Harmonic Current Test

### 5.1. Test Limit

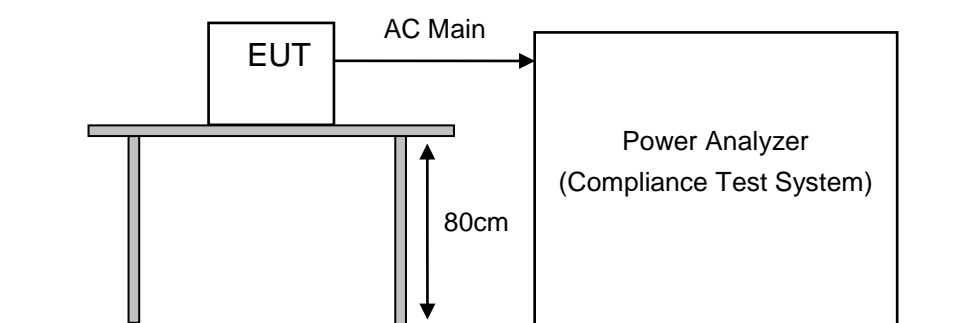
For Class A equipment:

Harmonic order $n$	Maximum permissible harmonic current A
<b>Odd harmonics</b>	
3	2,30
5	1,14
7	0,77
9	0,40
11	0,33
13	0,21
$15 \leq n \leq 39$	$0,15 \frac{15}{n}$
<b>Even harmonics</b>	
2	1,08
4	0,43
6	0,30
$8 \leq n \leq 40$	$0,23 \frac{8}{n}$

for Class A equipment:

The harmonics of the input current shall not exceed the values given in Class A equipment limit multiplied by a factor of 1,5.

### 5.2. Block Diagram of Test Setup



### 5.3. Configuration of EUT on Test

The following equipment are installed on Harmonic Current Test to meet the EN IEC 61000-3-2 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 5.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 5.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 5.5. Test Procedure

- (1) The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.
- (2) The test results are reported on Section 5.6.



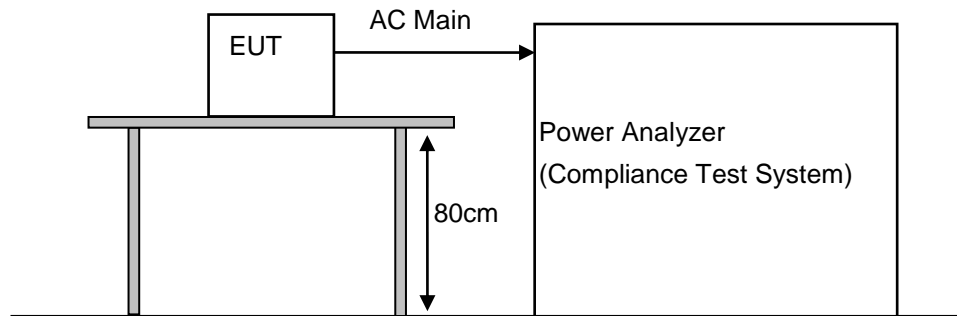
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### 5.6. Harmonic Current Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	N/A
M/N	:	CPU SR20XP	Temperature	:	N/A
Test Engineer	:	N/A	Humidity	:	N/A
Test Voltage	:	N/A	Pressure	:	N/A
Test Mode	:	N/A			
Test Results	:	N/A			
Note	:	1. The EUT actual Power is less than 75W, so it not applicable.			

## 6. Voltage Fluctuations & Flicker Test

### 6.1. Block Diagram Of Test Setup



### 6.2. Test Standard

EN 61000-3-3:2013+A2:2021

### 6.3. Voltage Fluctuation And Flicker Test Limits

Test Item	Limit	Note
$P_{st}$	1.0	$P_{st}$ means Short-term flicker indicator
$P_{lt}$	0.65	$P_{lt}$ means long-term flicker indicator
$T_{dt}$	0.2	$T_{dt}$ means maximum time that dt exceeds 3%
$d_{max}(\%)$	4%	$d_{max}$ means maximum relative voltage change.
$d_c(\%)$	3.3%	$d_c$ means relative steady-state voltage change.

#### 6.4. Configuration Of EUT On Test

The following equipment are installed on Harmonic Current Test to meet the EN 61000-3-3 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

#### 6.5. Operating Condition Of EUT

- (1) Setup the EUT as shown as Section 8.1.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

#### 6.6. Test Procedure

- (1) The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions During the flick measurement; the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.
- (2) The test results are reported on Section 8.7.

### 6.7. Voltage Fluctuation And Flicker Test Results

EUT	: PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	: 2023.7.27
M/N	: CPU SR20XP	Temperature	: 24℃
Test Engineer	: Jerry Yin	Humidity	: 56%
Test Voltage	: AC 230V/50Hz	Pressure	: 101.6kPa
Test Mode	: Data transmission		
Test Results	: PASS		
Note	: 1. The test results are listed in next pages.		

Temperature : 24.0°C

Humidity : 56.0%

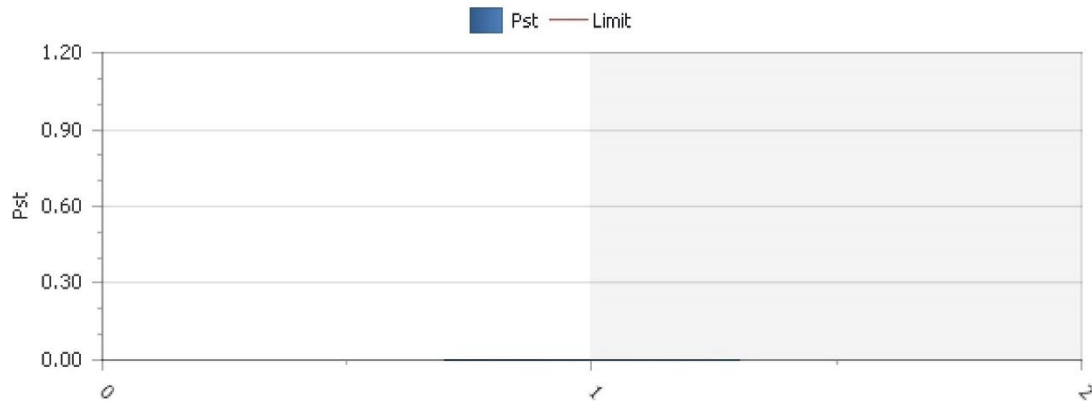
Test Volt. : 230.00V

Comments :

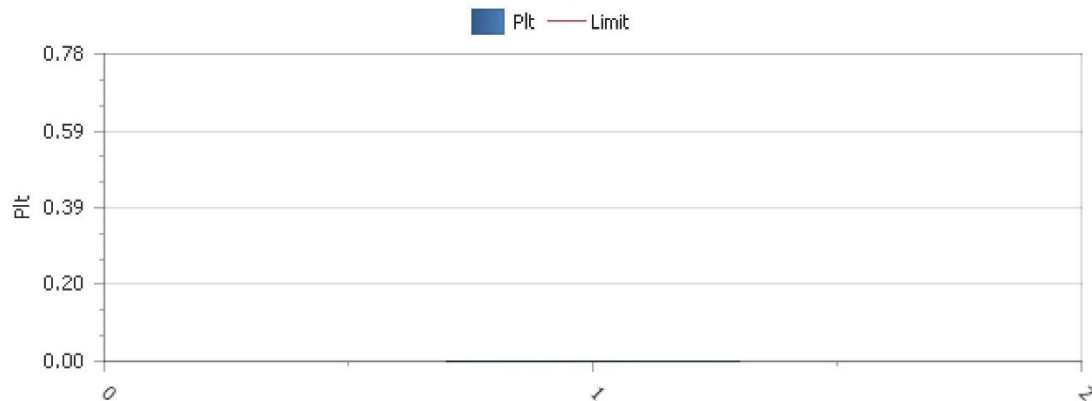
Customer : xxx

Result : PASS

Pst and Limit



Plt and Limit



Relevant Parameter and Judgement During Test Period

Vrms at the end of test(V) 229.92

Error Max(%)		Test Limit(%)		
T-max(ms)	0.00	Test Limit(ms)	500	Pass
dc(%)	0.00	Test Limit(%)	3.30	Pass
dmax(%)	0.00	Test Limit(%)	4.00	Pass
Pst	0.00	Test Limit	1.00	Pass
Plt	0.00	Test Limit	0.65	Pass

## 7. Immunity General performance criteria

### Performance Level

When assessing the impact of a disturbance on a function, the assessment should take into consideration the function's performance prior to the application of the disturbance and only identify as failures those changes in performance that are a result of the disturbance.

### Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

### Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

### Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

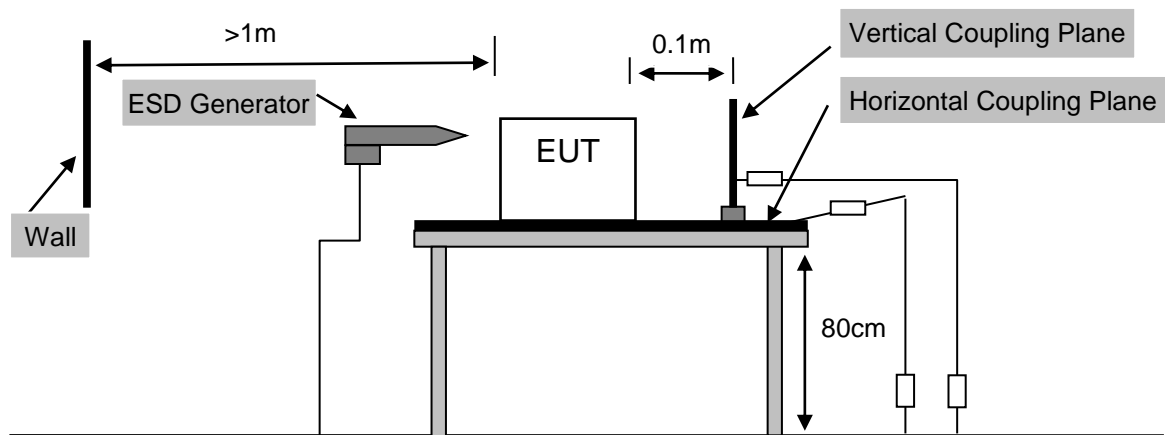
## 8. Electrostatic Discharge Test

### 8.1. Electrostatic Discharge Test Limits

Test Type	Test Level	Performance Criterion
Air Discharge	8KV	B
Contact Discharge	4KV	B

Notes: 1. Test set-up reference IEC 61000-4-2:2008

### 8.2. Block Diagram of Test Setup



### 8.3. Configuration of EUT on Test

The following equipment are installed on Electrostatic Discharge Test to meet the IEC 61000-4-2 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 8.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 8.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 8.5. Test Procedure

- (1) Air Discharge:
 

The test was applied on non-conductive surfaces of EUT. The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 20 times (10 with positive and 10 negative with positive ) for each pre-selected test point. This procedure was repeated until all the air discharge completed.

(2) Contact Discharge:

All the procedure was same as Section 8.5(1). Except that for the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.

(3) Indirect discharge for horizontal coupling plane:

At least 20 single discharges (10 with positive and 10 negative with positive) were applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

(4) Indirect discharge for vertical coupling plane:

At least 20 single discharge (10 with positive and 10 negative with positive) were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.



## 8.6. Electrostatic Discharge Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)		Test Date	:	2023.7.28	
M/N	:	CPU SR20XP		Temperature	:	24℃	
Test Engineer	:	Jerry Yin		Humidity	:	56%	
Test Voltage		AC 230V/50Hz		Pressure	:	101.6kPa	
Test Mode	:	Data transmission					
Test Results	:	PASS					
Discharge Voltage (kV)	Type Of Discharge	Dischargeable Points	Performance				
			Required	Observation			
±2	Contact	2	B	A			
±4	Contact	2	B	A			
±2	Air	1	B	A			
±4	Air	1	B	A			
±8	Air	1	B	A			
±4	HCP-Bottom	Edge of the HCP	B	A			
±4	VCP-Front	Center of the VCP	B	A			
±4	VCP-Left	Center of the VCP	B	A			
±4	VCP-Back	Center of the VCP	B	A			
±4	VCP-Right	Center of the VCP	B	A			
Discharge Points Description							
1	Gap		7	/			
2	Port		8	/			
3	/		9	/			
4.	/		10	/			
5.	/		11	/			
6.	/		12	/			
Note:	1. For the time interval between successive single discharges an initial value of one second. 2. For Air Discharge each Point Positive 10 times and negative 10 times discharge. 3. Class A is no function loss. 4. See the next page for test points.						

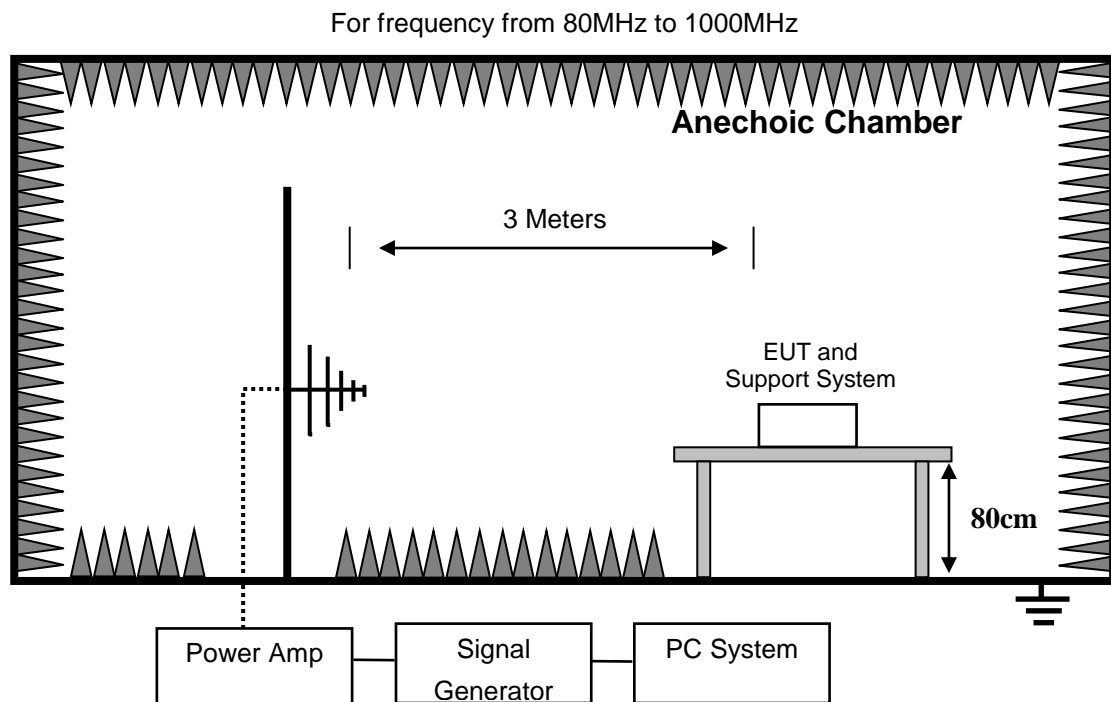
## 9. RF Field Strength Susceptibility Test

### 9.1. Test Level

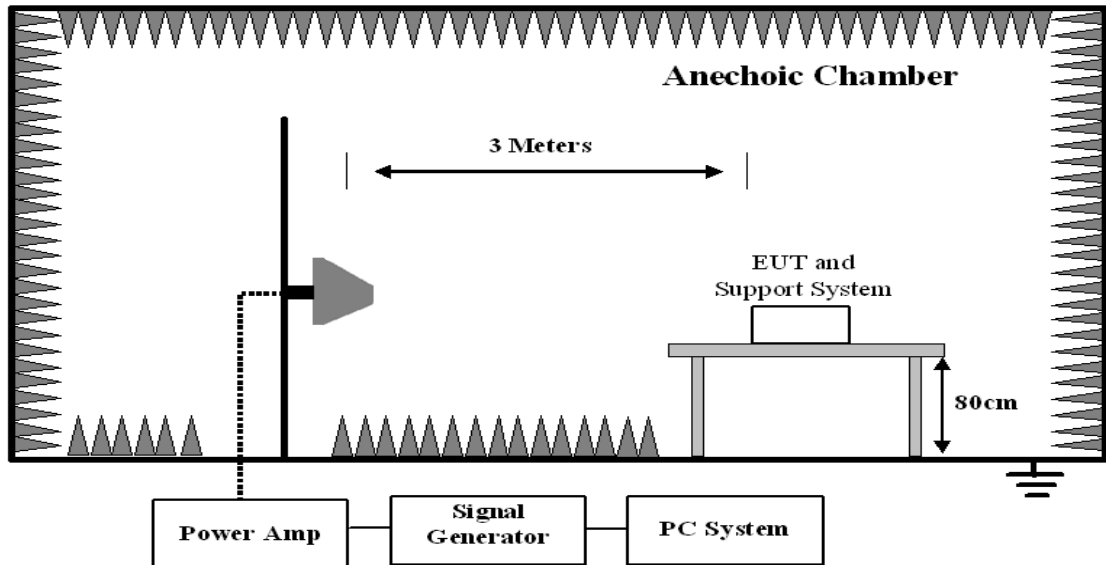
Test Specifications	Test Level	Performance Criterion
80MHz-1000MHz	3V/m (r.m.s.)	A
1800(±1%)MHz		A
2600(±1%)MHz		A
3500(±1%)MHz		A
5000(±1%)MHz		A

Notes: 1. Test set-up reference IEC 61000-4-3:2006 + A1:2007 + A2:2010

### 9.2. Block Diagram of Test Setup



For frequency above 1000MHz



### 9.3. Configuration of EUT on Test

The following equipment are installed on RF Field Strength Susceptibility Test to meet the IEC 61000-4-3 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 9.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 9.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 9.5. Test Procedure

- (1) Testing was performed in a Fully anechoic chamber as recommended by IEC 61000-4-3.  
The EUT was placed on an 80 cm high non-conductive table located in the area of field uniformity.
- (2) The radiating antenna was placed 3m in front of the EUT and Support system, and dwell time of the radiated interference was controlled by an automated, computer-controlled system.  
The signal source was stepped through the applicable frequency range at a rate no faster than 1% of the fundamental. The signal was amplitude modulated 80% over the frequency range 80 MHz to 1GHz at a level of 3 V/m. The dwell time was set at 1 s. Field presence was monitored during testing via a field probe placed in close proximity to the EUT.
- (3) Throughout testing, the EUT was closely monitored for signs of susceptibility. The test was performed with the antennae oriented in both a horizontal and vertical polarization.

### 9.6.RF Field Strength Susceptibility Test Results

EUT	: PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	: 2023.7.28
M/N	: CPU SR20XP	Temperature	: 24℃
Test Engineer	: Jerry Yin	Humidity	: 56%
Test Voltage	AC 230V/50Hz	Pressure	: 101.6kPa
Test Mode	: Data transmission		
Test Results	: PASS		
Note	: The test results are listed in next pages		

Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 kHz 80%					
Frequency Range	80 MHz -1000MHz				
Field strength	3V/m				
Steps	1%				
	Horizontal		Vertical		Result
	Required	Observation	Required	Observation	(Pass / Fail)
Front	A	A	A	A	Pass
Right	A	A	A	A	Pass
Rear	A	A	A	A	Pass
Left	A	A	A	A	Pass
Remark: Class A is no function loss					

Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 kHz 80%					
Frequency Range	1800(±1%) MHz				
Field strength	3V/m				
Steps	spot test				
	Horizontal		Vertical		Result
	Required	Observation	Required	Observation	(Pass / Fail)
Front	A	A	A	A	Pass
Right	A	A	A	A	Pass
Rear	A	A	A	A	Pass
Left	A	A	A	A	Pass
Remark: Class A is no function loss					

Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 kHz 80%					
Frequency Range	2600(±1%) MHz				
Field strength	3V/m				
Steps	spot test				
	Horizontal		Vertical		Result
	Required	Observation	Required	Observation	(Pass / Fail)
Front	A	A	A	A	Pass
Right	A	A	A	A	Pass
Rear	A	A	A	A	Pass
Left	A	A	A	A	Pass
Remark: Class A is no function loss					

Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 kHz 80%					
Frequency Range	3500(±1%) MHz				
Field strength	3V/m				
Steps	spot test				
	Horizontal		Vertical		Result
	Required	Observation	Required	Observation	(Pass / Fail)
Front	A	A	A	A	Pass
Right	A	A	A	A	Pass
Rear	A	A	A	A	Pass
Left	A	A	A	A	Pass
Remark: Class A is no function loss					

Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 kHz 80%					
Frequency Range	5000(±1%) MHz				
Field strength	3V/m				
Steps	spot test				
	Horizontal		Vertical		Result
	Required	Observation	Required	Observation	(Pass / Fail)
Front	A	A	A	A	Pass
Right	A	A	A	A	Pass
Rear	A	A	A	A	Pass
Left	A	A	A	A	Pass
Remark: Class A is no function loss					

## 10. Electrical Fast Transient/Burst Immunity Test

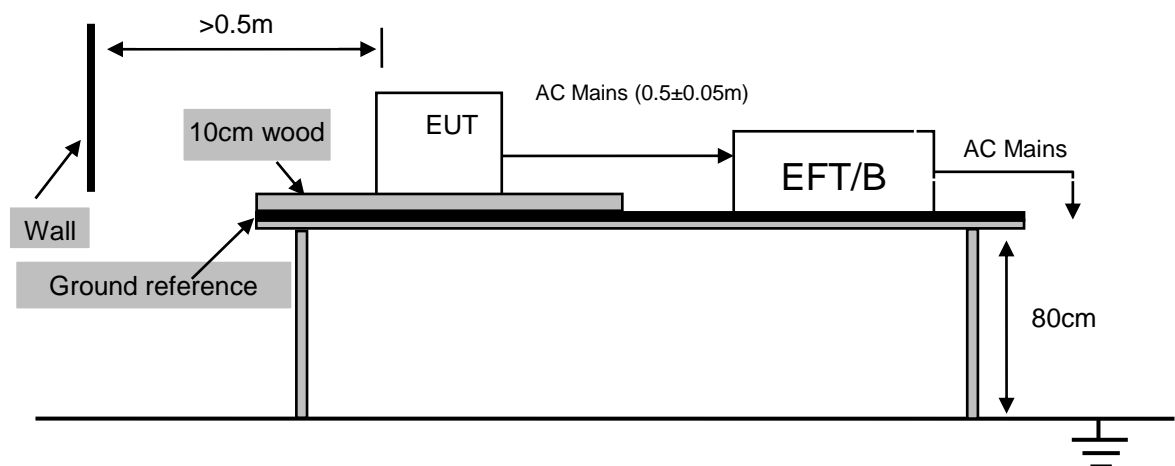
### 10.1. Test Level

For AC mains power ports		
Test Specifications	Test Level	Performance Criterion
Tr/Th Repetition: 5/50ns Frequency: 5kHz	1KV	B
For DC network power ports and analogue/digital data ports		
Test Specifications	Test Level	Performance Criterion
Tr/Th Repetition: 5/50ns Frequency: 5kHz	0.5KV	B

Notes:

1. Test set-up reference IEC 61000-4-4:2012

### 10.2. Block Diagram of Test Setup



### 10.3. Configuration of EUT on Test

The following equipment are installed on Electrical Fast Transient/Burst immunity Test to meet the IEC 61000-4-4 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 10.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 10.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

## 10.5. Test Procedure

- The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support 0.1m + 0.01m thick. The ground reference plane was 1m\*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane was project beyond the EUT by at least
- (1) 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m. All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables.

### 8.6.1. For input and AC power ports:

The EUT was connected to the power mains by using a coupling device that couples the EFT interference signal to AC power lines. Both positive transients and negative transients of test voltage were applied during compliance test and the duration of the test can't less than 1min.

### 8.6.2. For signal lines and control lines ports:

It's unnecessary to test.

### 8.6.3. For DC input and DC output power ports:

It's unnecessary to test.



## 10.6.Electrical Fast Transient/Burst Immunity Test Results

EUT	: PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	: 2023.7.28
M/N	: CPU SR20XP	Temperature	: 24℃
Test Engineer	: Jerry Yin	Humidity	: 56%
Test Voltage	: AC 230V/50Hz	Pressure	: 101.6kPa
Test Mode	: Data transmission		
Test Results	: PASS		
Note	: /		

Repetition Frequency : 5 kHz      Burst Duration : 15ms      Burst Period: 300ms

Inject Time(s): 120s      Inject Method: Direct

Inject Line: ☒ AC Mains    ☐ DC Supply    ☐ Signal

Line	Test Voltage	Performance			Result
		Required	Observation(+ )	Observation( - )	(Pass/Fail)
L	1kV	B	A	A	Pass
N	1kV	B	A	A	Pass
L N	1kV	B	A	A	Pass
L-PE	1kV	B	A	A	Pass
N-PE	1kV	B	A	A	Pass
L-N-PE	1kV	B	A	A	Pass
Signal Line	/	/	/	/	/

Remark : 1. Class A is no function loss

## 11. Surge Test

### 11.1. Test Level

For AC mains power ports

Test Specifications	Test Level	Performance Criterion
Tr/Th Repetition: 1,2/50 (8/20)ns Between line and line	1 KV	B
Tr/Th Repetition: 1,2/50 (8/20)ns Between line and earth (ground)	2 KV	B

For DC network power ports

Test Specifications	Test Level	Performance Criterion
Tr/Th Repetition: 1,2/50 (8/20)ns Line to reference ground for each individual line	0.5 KV	B

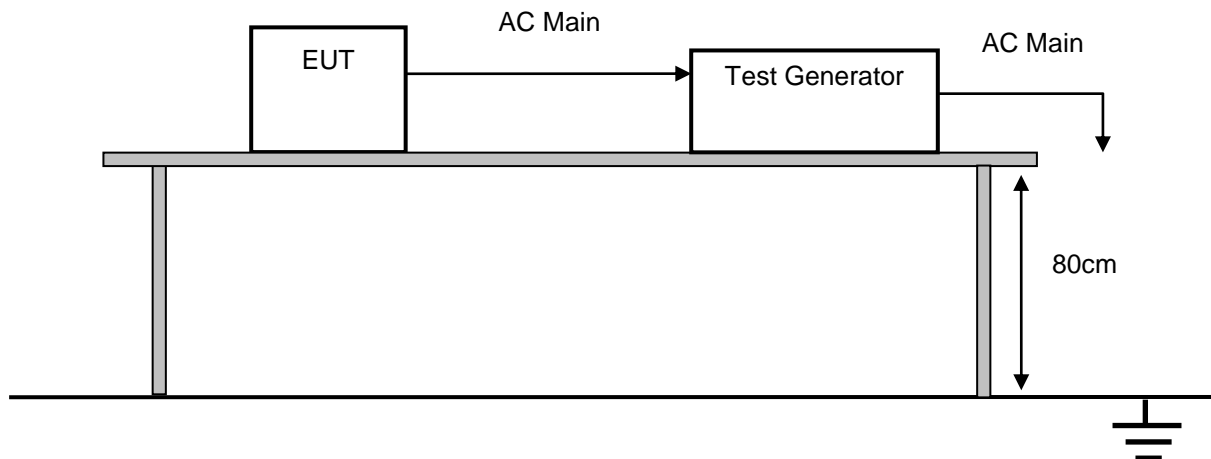
For analogue/digital data ports

Test Specifications	Test Level	Performance Criterion
Tr/Th Repetition: 10/700 (5/320)ns unshielded symmetrical: lines to ground Apply where primary protection is intended	1 KV/4KV <sup>a b</sup>	C
Tr/Th Repetition: 10/700 (5/320)ns unshielded symmetrical: lines to ground Apply where primary protection is not intended	1 KV <sup>b</sup>	C
Tr/Th Repetition: 1,2/50 (8/20)ns coaxial or shielded: shield to ground	0.5KV <sup>c</sup>	B

- Notes:
1. Test set-up reference IEC 61000-4-5:2014+A1:2017
  2. <sup>a</sup> is surges are applied with primary protection fitted. Where possible, use the actual primary protector intended to be used in the installation.
  3. <sup>b</sup> is Where the surge coupling network for the 10/700 (5/320)  $\mu$ s waveform affects the functioning of high speed data ports, the test shall be carried out using a 1,2/50 (8/20)  $\mu$ s waveform and appropriate coupling network.
  4. <sup>a</sup> is Surges are applicable to ports which satisfy all the following conditions:
    - may connect directly to cables that leave the building structure,
    - defined as an antenna port, a wired network port, or a broadcast receiver tuner port see the standard EN 55035 section 3.

Typical ports covered include xDSL, PSTN, CATV, antenna and similar. Excluded ports are LAN and similar.

## 11.2. Block Diagram of Test Setup



## 11.3. Configuration of EUT on Test

The following equipment are installed on Surge Test to meet the IEC 61000-4-5 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

## 11.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 11.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

## 11.5. Test Procedure

- For line-to-line coupling mode, provide a 1kV 1.2/50us voltage surge (at open-circuit condition) and
- (1) 8/20us current surge to EUT selected points, and for active line / neutral lines to ground are same except test level is 2kV.
  - (2) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test.
  - (3) Different phase angles are done individually.
  - (4) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

### 11.6.Surge Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	2023.7.28
M/N	:	CPU SR20XP	Temperature	:	24℃
Test Engineer	:	Jerry Yin	Humidity	:	56%
Test Voltage	:	AC 230V/50Hz	Pressure	:	101.6kPa
Test Mode	:	Data transmission			
Test Results	:	PASS			
Note: /					

No. of phase: 5 Times/Phase Angle					Interval: 60 Seconds						
Line : <input checked="" type="checkbox"/> AC Mains <input type="checkbox"/> DC Supply <input type="checkbox"/> Signal											
Location	Volt	500V			1kV			2kV			Result
	Phase	Performance			Performance			Performance			(Pass/Fail)
		Required	+	-	Required	+	-	Required	+	-	
L-N	0°	/	/	/	/	/	/	/	/	/	/
	90°	/	/	/	B	A	/	/	/	/	Pass
	180°	/	/	/	/	/	/	/	/	/	/
	270°	/	/	/	B	/	A	/	/	/	Pass
L-PE	0°	/	/	/	/	/	/	/	/	/	/
	90°	/	/	/	/	/	/	B	A	/	Pass
	180°	/	/	/	/	/	/	/	/	/	/
	270°	/	/	/	/	/	/	B	/	A	Pass
N-PE	0°	/	/	/	/	/	/	/	/	/	/
	90°	/	/	/	/	/	/	B	A	/	Pass
	180°	/	/	/	/	/	/	/	/	/	/
	270°	/	/	/	/	/	/	B	/	A	Pass
Network Port	/	/	/	/	/	/	/	/	/	/	/
Remark: 1. Class A is no function loss											

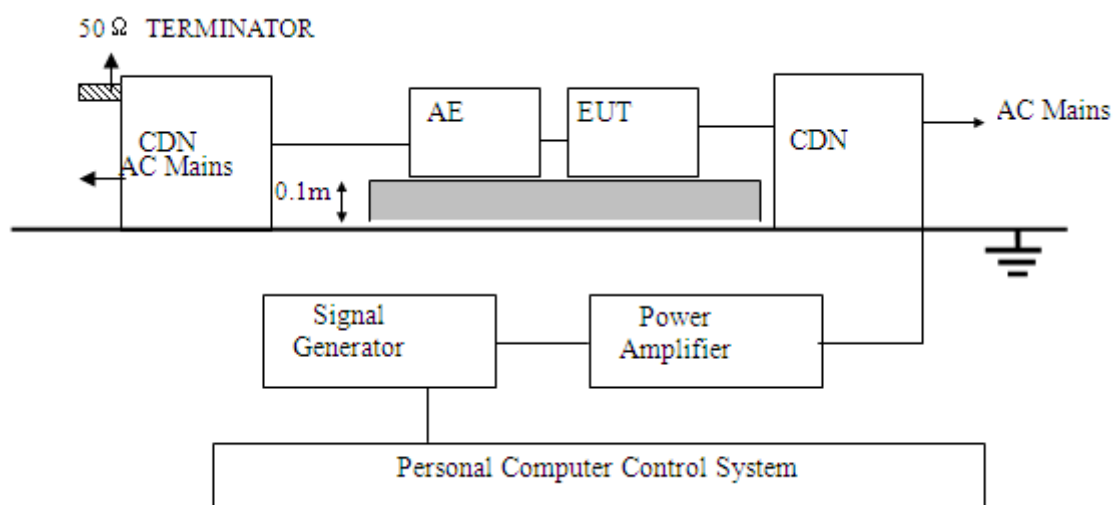
## 12. Injected Currents Susceptibility Test

### 12.1. Test Level

Test Specifications	Test Level	Performance Criterion
0,15 to 10MHz	3 V	A
10 to 30MHz	3 to 1 V	
30 to 80MHz	1 V	

Notes: 1. Test set-up reference IEC 61000-4-6:2013

### 12.2. Block Diagram of Test Setup



### 12.3. Configuration of EUT on Test

The following equipment are installed on Injected currents susceptibility Test to meet the IEC 61000-4-6 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 12.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 12.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

## 12.5. Test Procedure

- (1) Let the EUT work in test mode and test it.  
The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables
- (2) between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 10 and 30 mm (where possible).
- (3) The disturbance signal described below is injected to EUT through CDN.
- (4) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- (5) The frequency range is swept from 0.150MHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.
- (6) The rate of sweep shall not exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- (7) Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

## 12.6.Injected Currents Susceptibility Test Results

EUT	: PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	: 2023.7.28
M/N	: CPU SR20XP	Temperature	: 24℃
Test Engineer	: Jerry Yin	Humidity	: 56%
Test Voltage	: AC 230V/50Hz	Pressure	: 101.6kPa
Test Mode	: Data transmission		
Test Results	: PASS		

Frequency Range (MHz)	Injected Position	Voltage Level (e.m.f.)	Required	Observation	Result (Pass / Fail)
0.15 ~ 10	AC Line	3V	A	A	PASS
10 ~ 30	AC Line	3V~1V	A	A	PASS
30 ~ 80	AC Line	1V	A	A	PASS

Step :   1   %                      Dwell Time :   1   Sec

Direct CDN Type :    ☐ M2        ☒ M3        ☐ Clamp

Modulation Signal:1kHz 80% AM

Remark: Class A is no function loss.

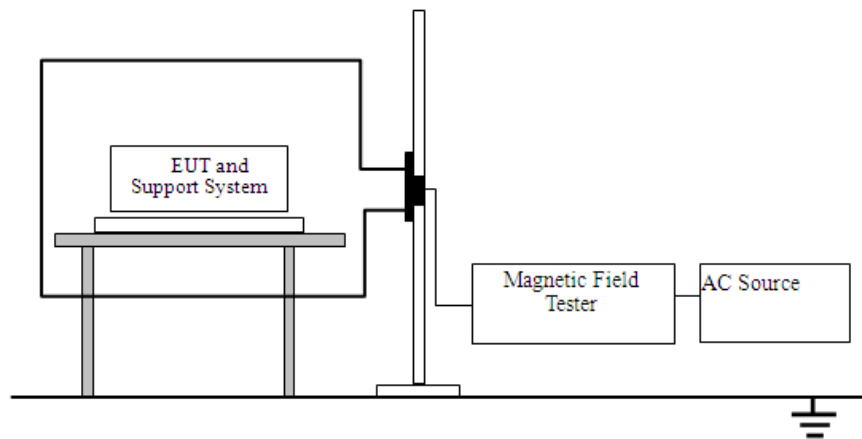
## 13. Magnetic Field Immunity Test

### 13.1. Test Level

Test Specifications	Test Level	Performance Criterion
50 or 60 Hz	1 A/m	A

- Notes:
1. Test set-up reference IEC 61000-4-8:2009
  2. This test applicable only to equipment containing devices intrinsically susceptible to magnetic fields, such as CRT monitors, Hall effect elements, electro-dynamic microphones, magnetic field sensors or audio frequency transformers. Refer to D.3.2 for determining the test level when the EUT contains a CRT display.

### 13.2. Block Diagram of Test Setup



### 13.3. Configuration of EUT on Test

The following equipment are installed on Magnetic field immunity Test to meet the IEC 61000-4-8 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 13.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 13.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 13.5. Test Procedure

The EUT was subjected to the test magnetic field by using the induction coil of standard dimensions

- (1) (1m\*1m) and shown in Section 13.2. The induction coil was then rotated by 90° in order to expose the EUT to the test field with different orientations.



### 13.6.Magnetic Field Immunity Test Results

EUT	:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	N/A
M/N	:	CPU SR20XP	Temperature	:	N/A
Test Engineer	:	N/A	Humidity	:	N/A
Test Voltage	:	N/A	Pressure	:	N/A
Test Mode	:	N/A			
The EUT not containing devices susceptible to magnetic fields, and Power-frequency magnetic field test applicable only to EUT containing devices susceptible to magnetic fields, so the test not applicable.					

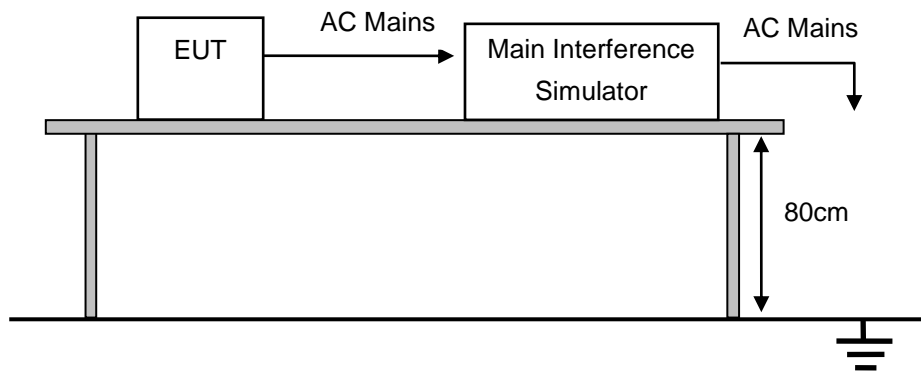
## 14. Voltage Dips And Interruptions Test

### 14.1. Test Level

Test Level %UT	Voltage dip and short interruptions %UT	Performance Criterion	Duration (in period)
< 5	100	C	250
< 5	100	B	0.5
70	30	C	25

Notes: 1. Test set-up reference IEC 61000-4-11:2020

### 14.2. Block Diagram of Test Setup



### 14.3. Configuration of EUT on Test

The following equipment are installed on Voltage dips and interruptions Test to meet the IEC 61000-4-11 requirements and operating regulations in a manner that tends to maximize its emission characteristics in normal application.

### 14.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 14.2.
- (2) Turn on the power of all equipment.
- (3) Let the EUT work in test mode and 15 minutes before taking the test.

### 14.5. Test Procedure

- (1) The interruption is introduced at selected phase angles with specified duration.
- (2) Record any degradation of performance.

## 14.6.Voltage Dips And Interruptions Test Results

EUT		:	PROGRAMMABLE LOGIC CONTROLLER(PLC)	Test Date	:	2023.7.28
M/N		:	CPU SR20XP	Temperature	:	24℃
Test Engineer		:	Jerry Yin	Humidity	:	56%
Test Voltage		:	AC 230V/50Hz	Pressure	:	101.6kPa
Test Mode		:	Data transmission			
Test Results		:	PASS			
Note:	/					

Test Level % $U_T$	Voltage Dips & Short Interruptions % $U_T$	Duration (in period)	Phase Angle	Required	Observation	Result (Pass / Fail)
0	100	0.5P	0° -360°	B	A	PASS
70	30	25P	0° -360°	C	B	PASS
0	100	250P	0° -360°	C	B	PASS

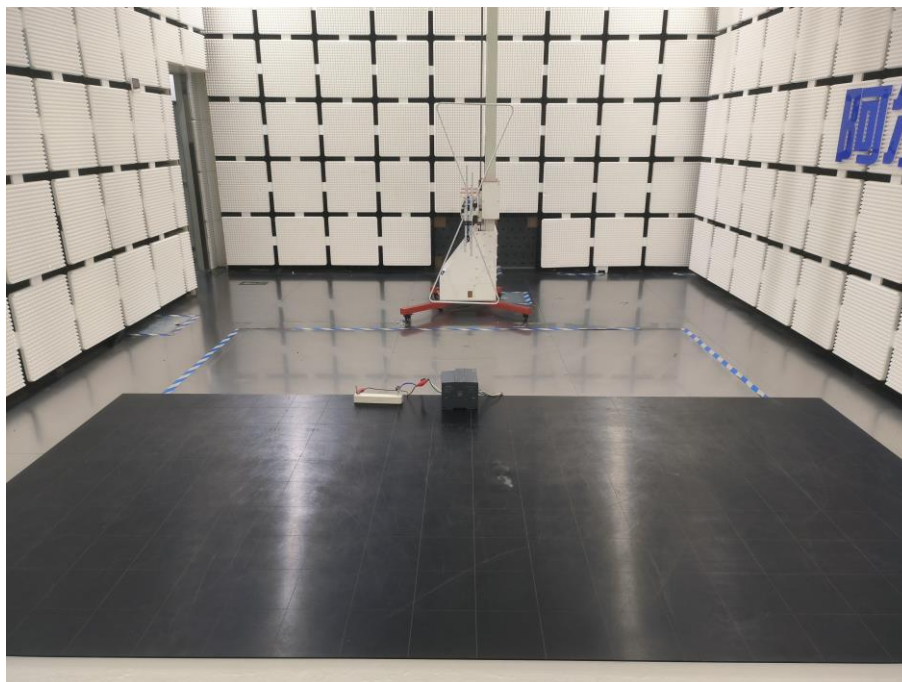
Note: 1.  $U_T$  is the rated voltage for the equipment.

2. Class B is EUT stop charging, but it can automatically reply.

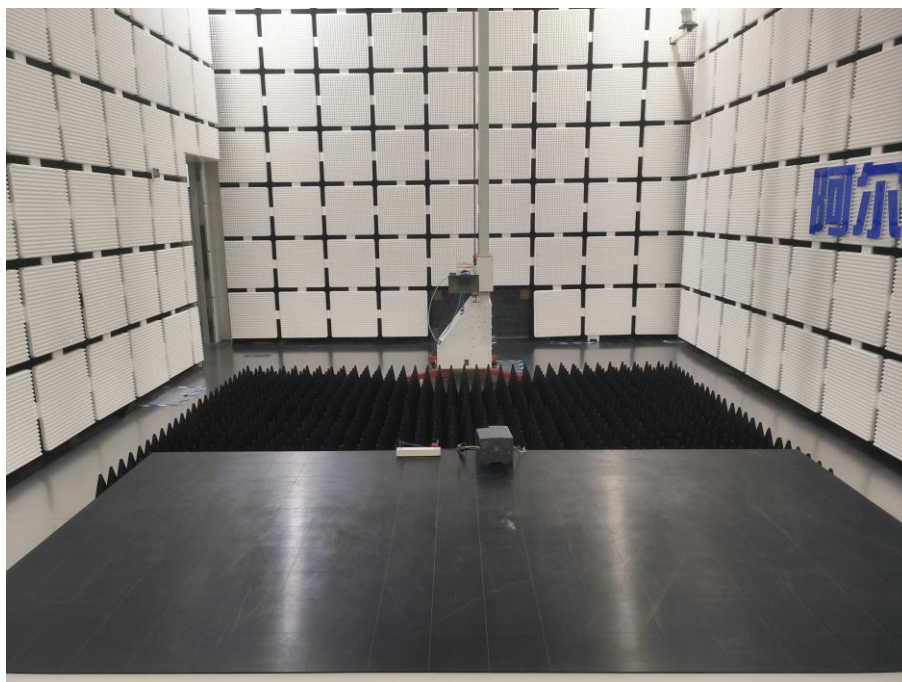
3. Class A is no faction loss.

## 15. Photograph

### 15.1.Photo Of Radiated Emissions Test (In Semi Anechoic Chamber)



### 15.2.Photo Of Radiated Emissions Test (Above 1G)



### 15.3.Photo Of Conducted Emissions At Mains Terminals Test



### 15.4.Photo of Electrostatic Discharge Test



### 15.5.Photo of EFT & Voltage Dips & Surge Test



### 15.6.Photos of Flicker Test

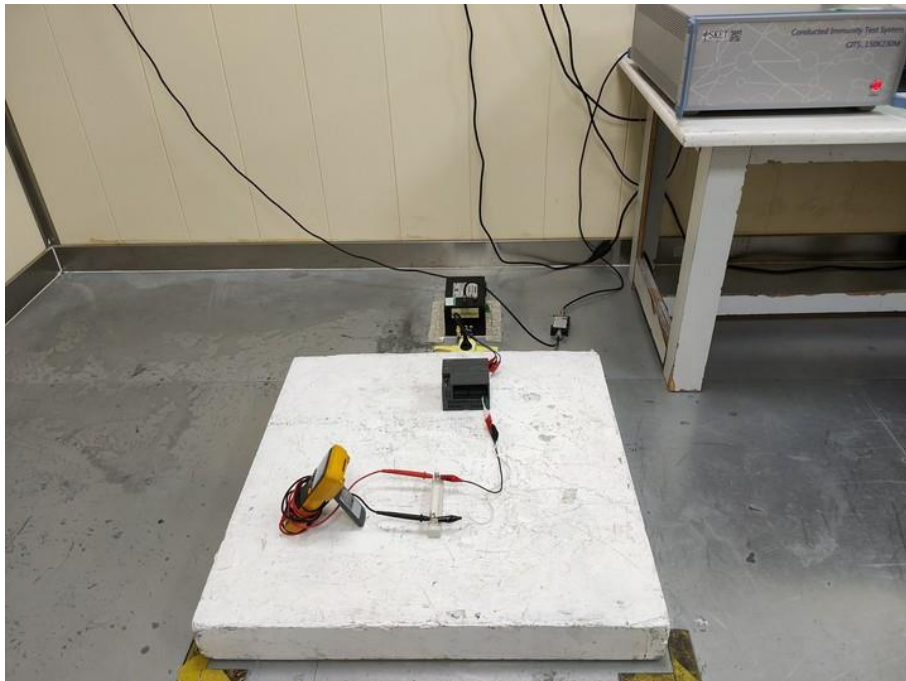




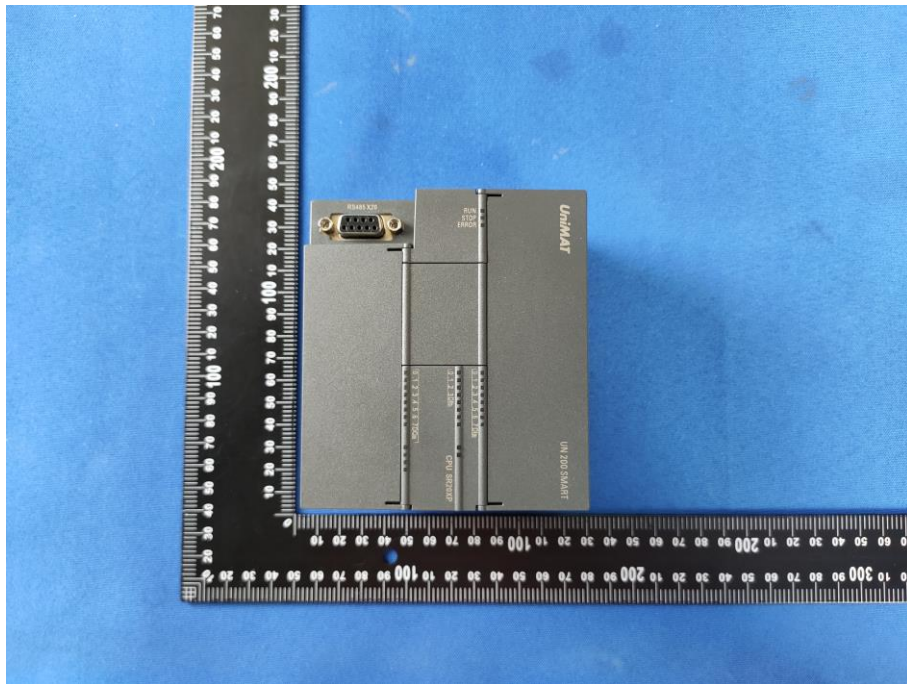
### 15.7.Photo of RF Field Strength Susceptibility Test



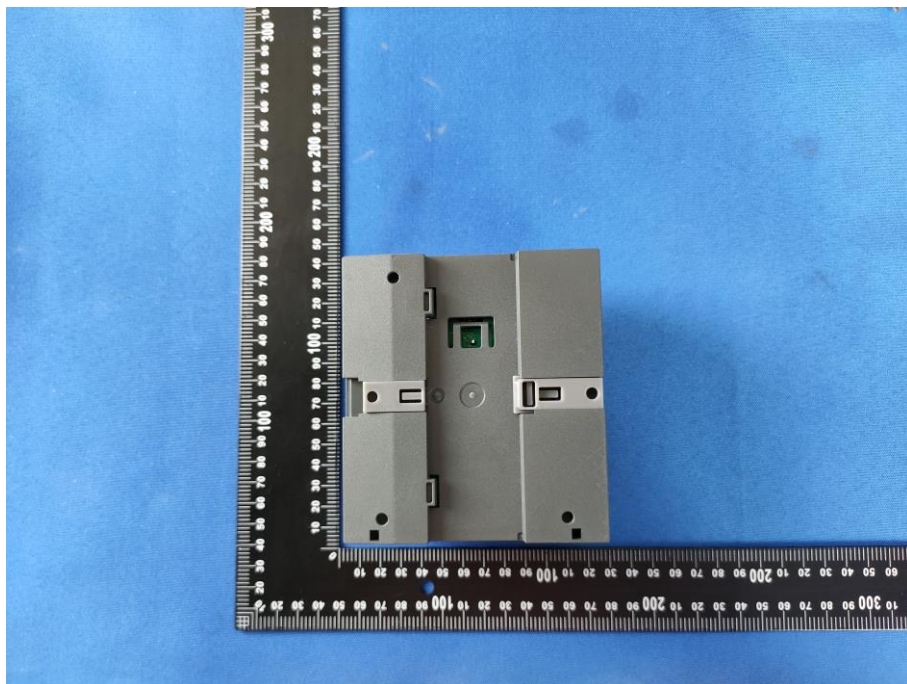
### 15.8.Photo of Injected Currents Susceptibility Test



## 16. Photos Of The EUT

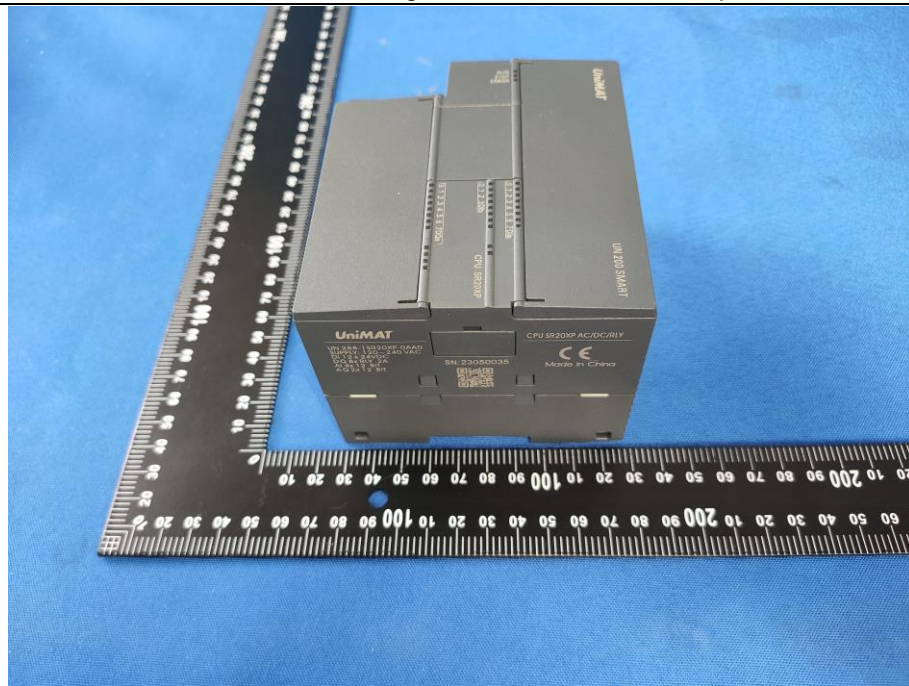


EUT View

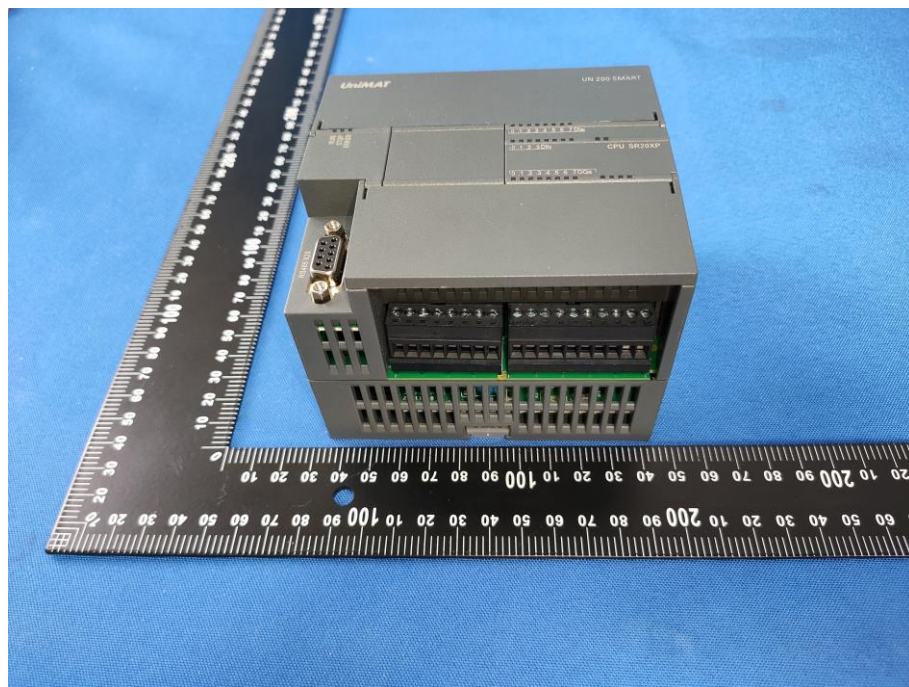


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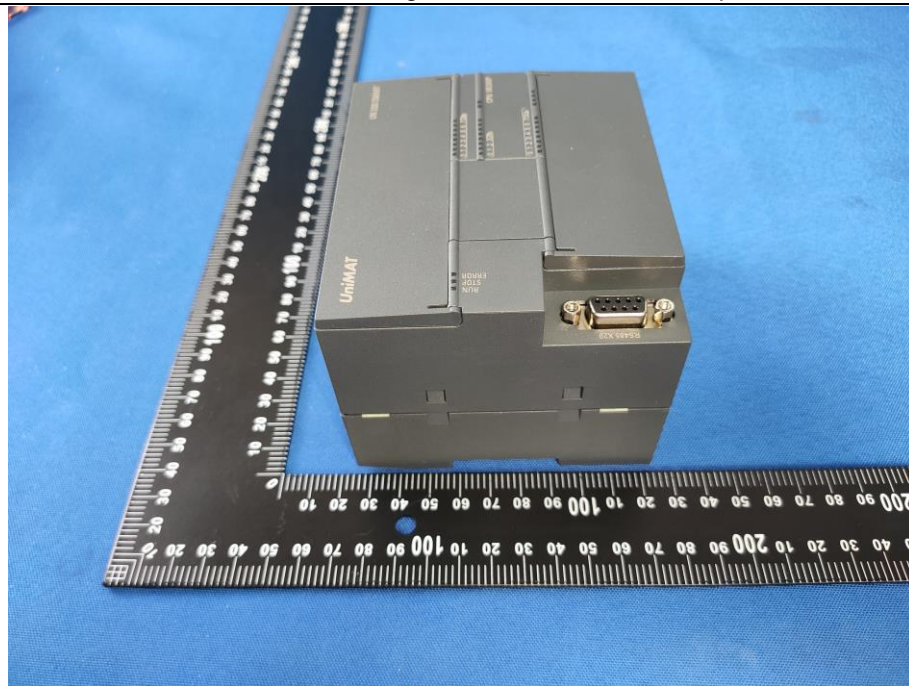




EUT View



EUT View

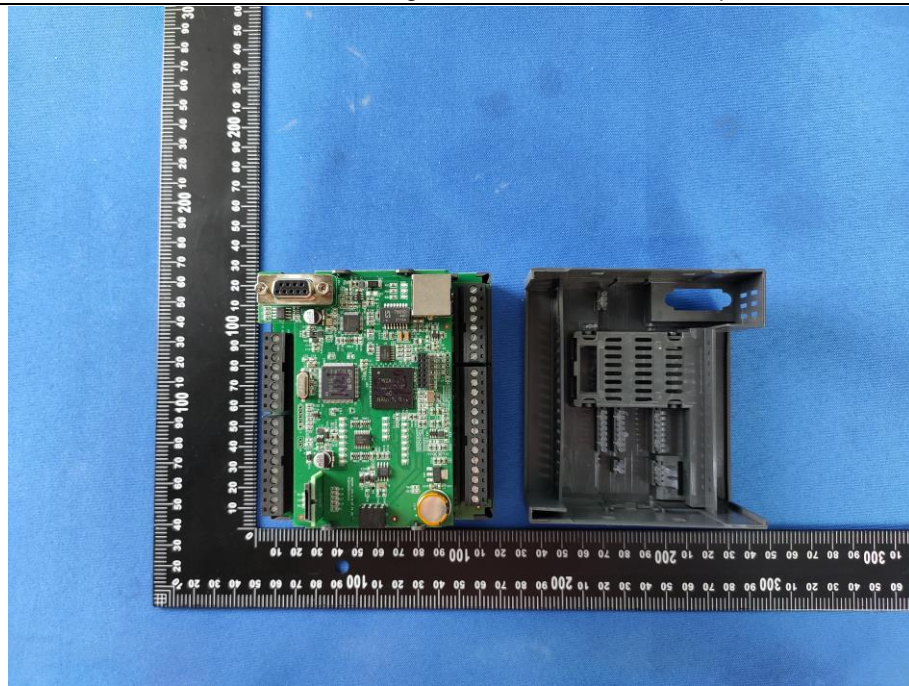


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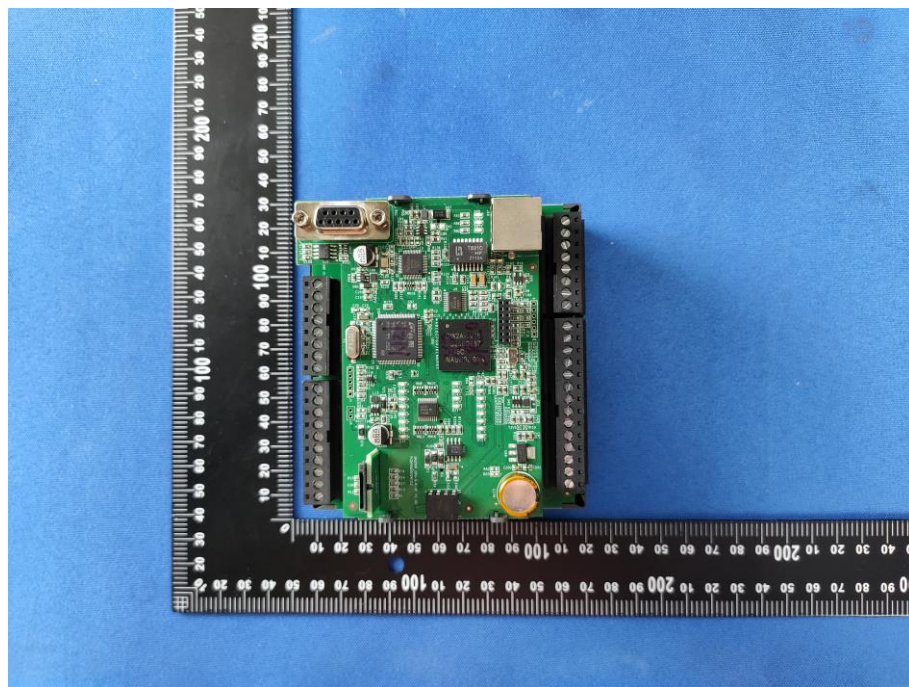


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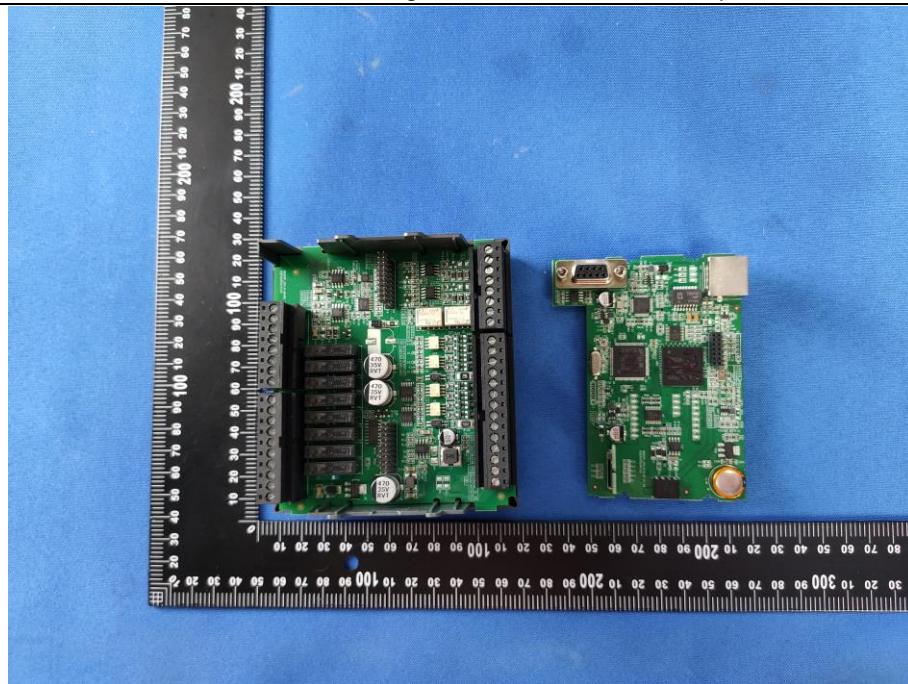




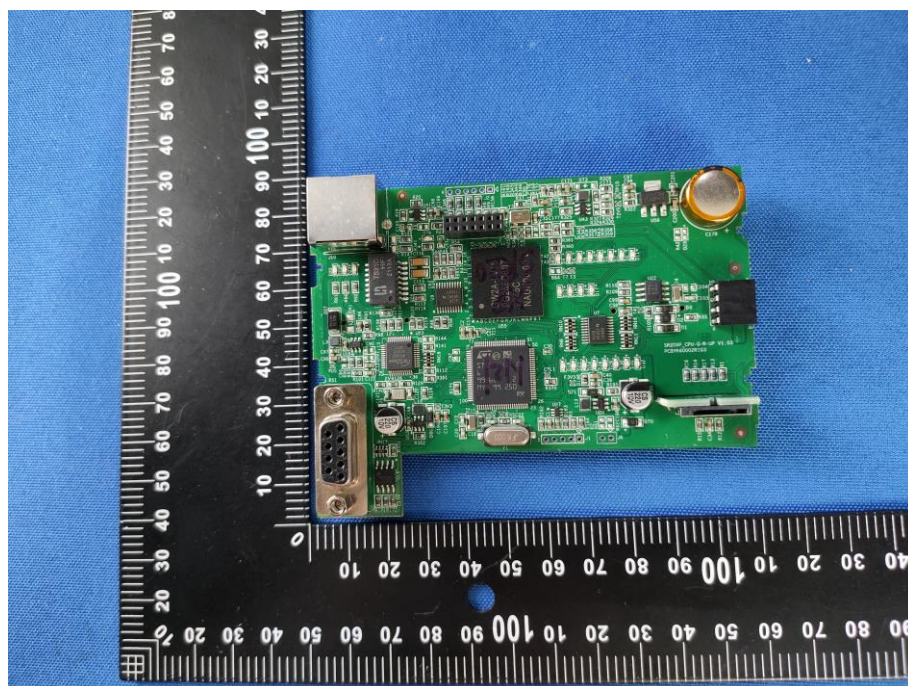
EUT View



EUT View

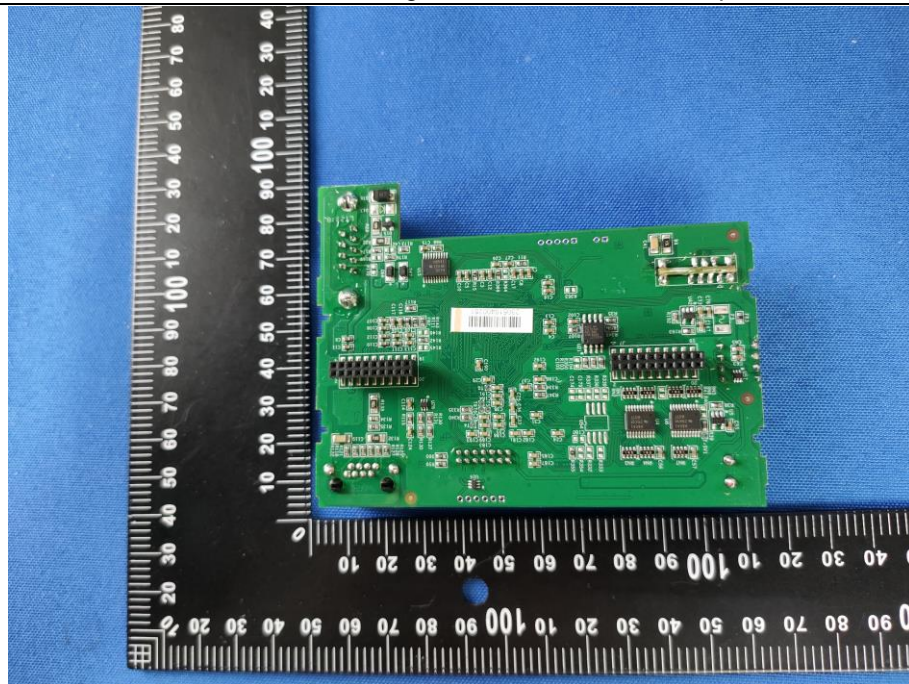


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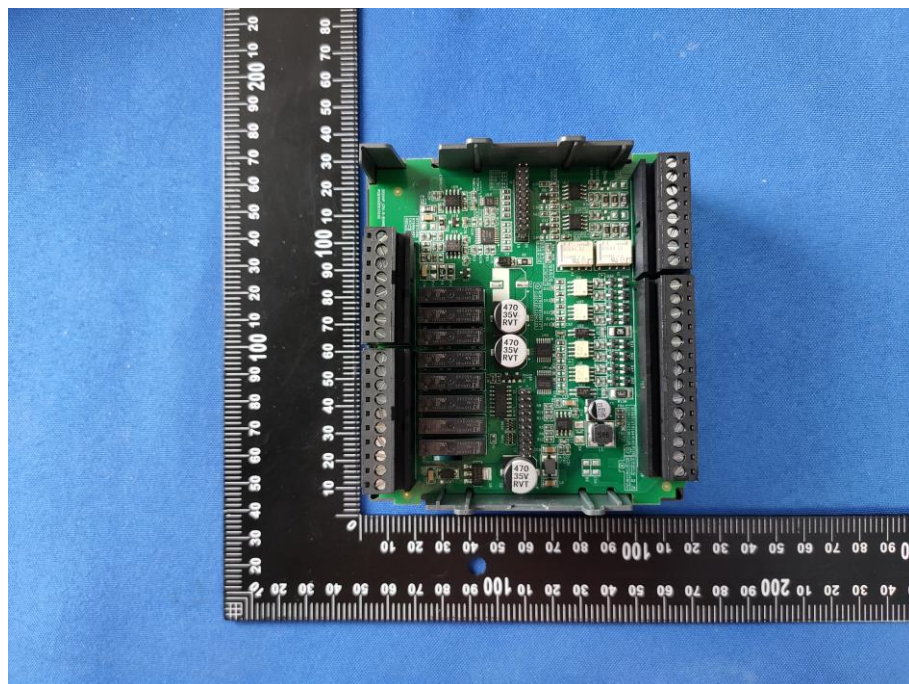


EUT View

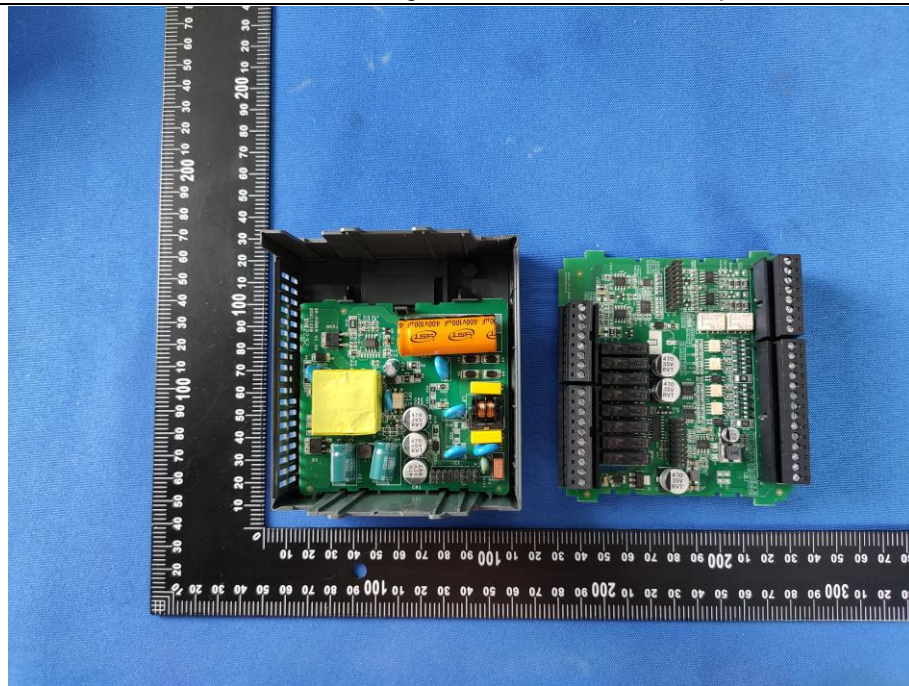




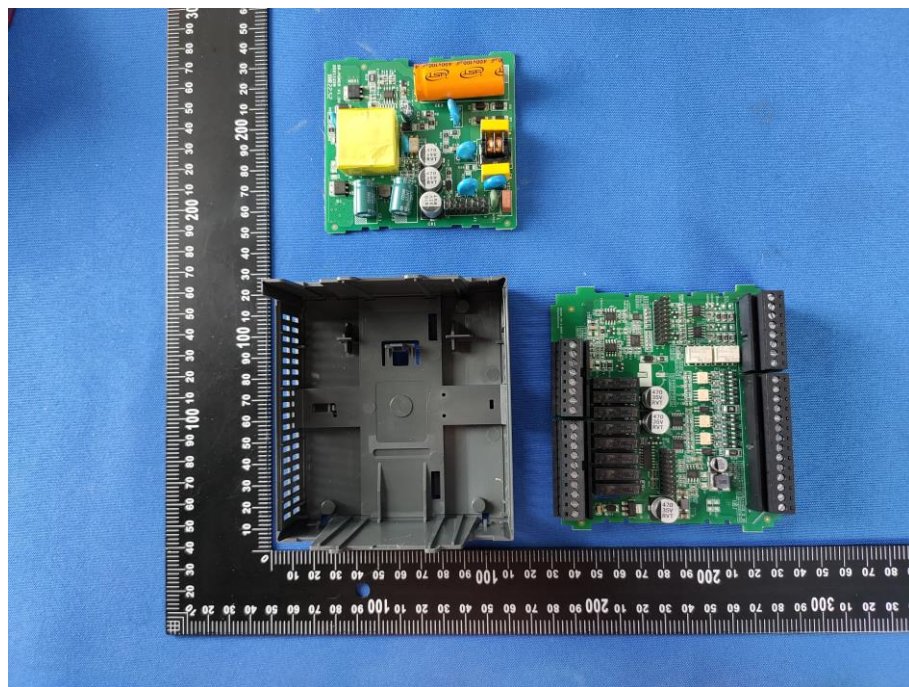
EUT View



EUT View

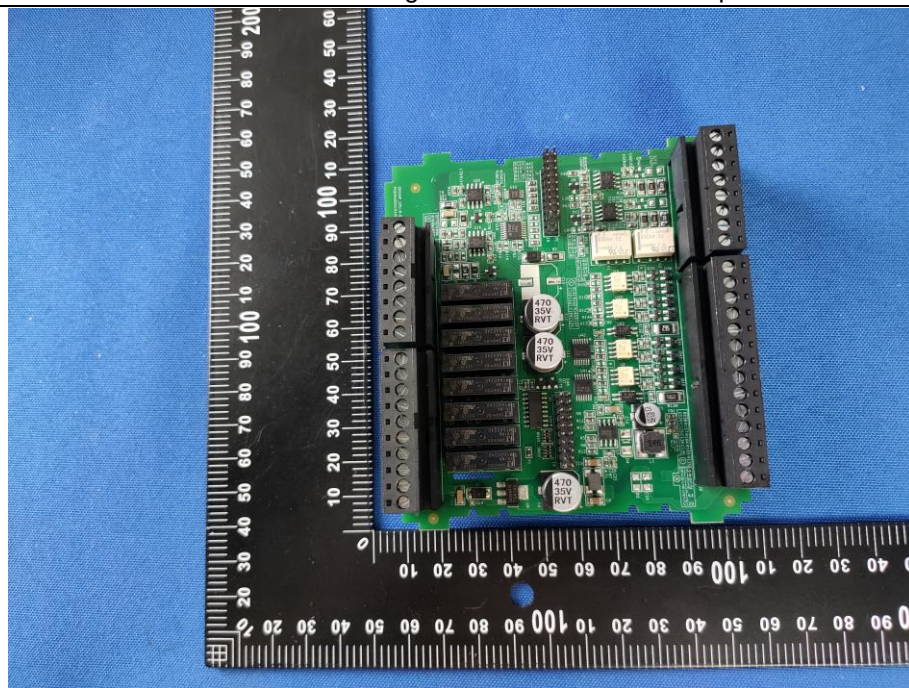


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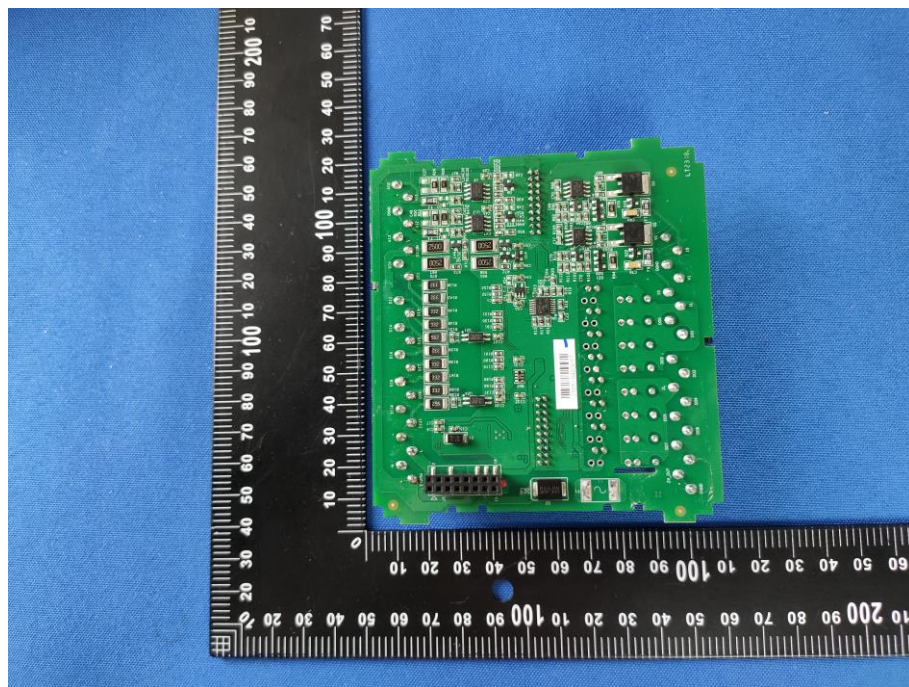


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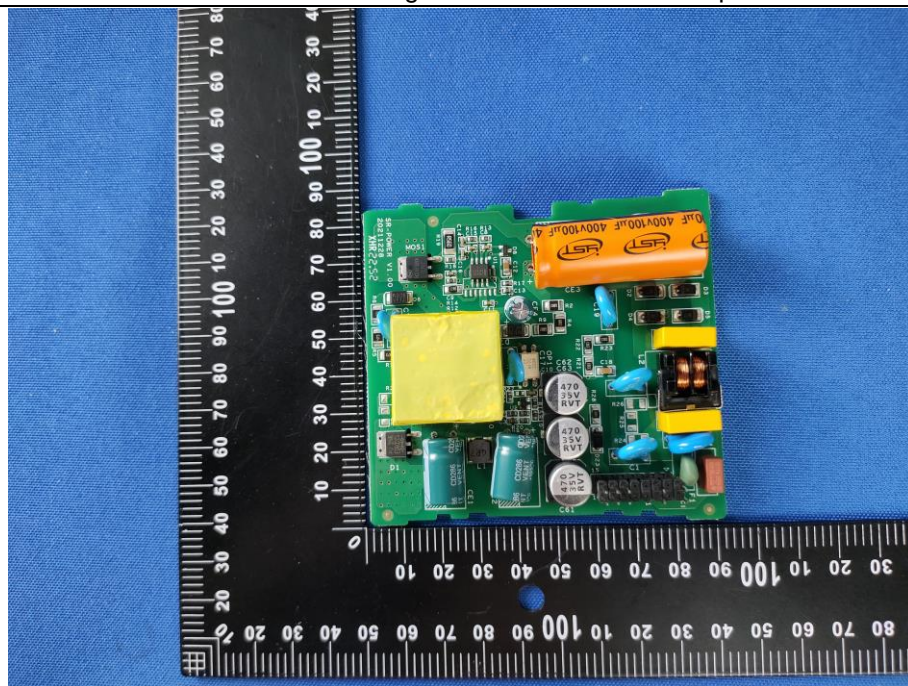


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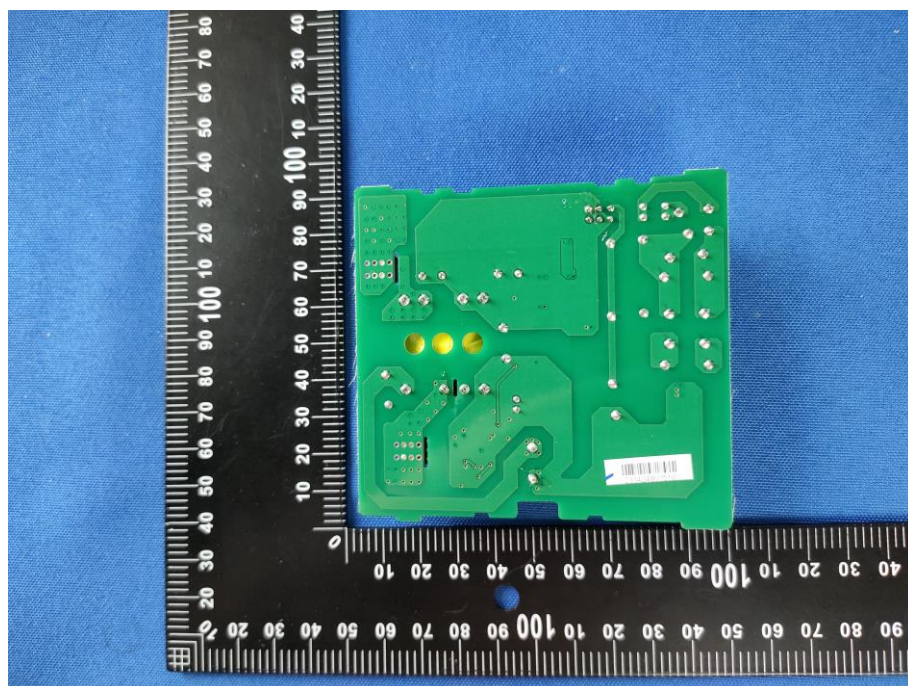


EUT View





EUT View



EUT View

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